

## ISO774x High-Speed, Robust-EMC Reinforced Quad-Channel Digital Isolators

### 1 Features

- Signaling Rate: Up to 100 Mbps
- Wide Supply Range: 2.25 V to 5.5 V
- 2.25-V to 5.5-V Level Translation
- Default Output *High* and *Low* Options
- Wide Temperature Range:  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$
- Low Power Consumption, Typical 1.5 mA per Channel at 1 Mbps
- Low Propagation Delay: 10.7 ns Typical (5-V Supplies)
- High CMTI:  $\pm 100\text{ kV}/\mu\text{s}$  Typical
- Robust Electromagnetic Compatibility (EMC)
  - System-Level ESD, EFT, and Surge Immunity
  - Low Emissions
- Isolation Barrier Life: >40 Years
- Wide-SOIC (DW-16) and QSOP (DBQ-16) Package Options
- Safety-Related Certifications:
  - DIN V VDE V 0884-10 (VDE V 0884-10): 2006-12
  - UL 1577 Component Recognition Program
  - CSA Component Acceptance Notice 5A, IEC 60950-1 and IEC 60601-1 End Equipment Standards
  - CQC Approval per GB4943.1-2011
  - TUV Certification according to EN 60950-1 and EN 61010-1
  - Certifications for DW Package Complete; All Other Certifications are Planned

### 2 Applications

- Industrial Automation
- Motor Control
- Power Supplies
- Solar Inverters
- Medical Equipment

### 3 Description

The ISO774x devices are high-performance, quad-channel digital isolators with 5000  $V_{\text{RMS}}$  (DW package) and 2500  $V_{\text{RMS}}$  (DBQ package) isolation ratings per UL 1577. This family of devices has reinforced insulation ratings according to VDE, CSA, TUV and CQC.

The ISO774x devices provide high electromagnetic immunity and low emissions at low power consumption, while isolating CMOS or LVCMOS digital I/Os. Each isolation channel has a logic input and output buffer separated by silicon dioxide ( $\text{SiO}_2$ ) insulation barrier. This device comes with enable pins which can be used to put the respective outputs in high impedance for multi-master driving applications and to reduce power consumption. The ISO7740 device has all four channels in the same direction, the ISO7741 device has three forward and one reverse-direction channels, and the ISO7742 device has two forward and two reverse-direction channels. If the input power or signal is lost, default output is *high* for devices without suffix F and *low* for devices with suffix F. See the [Device Functional Modes](#) section for further details.

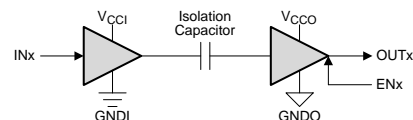
Used in conjunction with isolated power supplies, this device helps prevent noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry. Through innovative chip design and layout techniques, electromagnetic compatibility of the ISO774x devices have been significantly enhanced to ease system-level ESD, EFT, surge, and emissions compliance. The ISO774x devices are available in 16-pin SOIC and QSOP packages.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
ISO7740	SOIC (DW)	10.30 mm x 7.50 mm
ISO7741 ISO7742	SSOP (DBQ)	4.90 mm x 3.90 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Simplified Schematic



$V_{\text{CCI}}$  and  $\text{GNDI}$  are supply and ground connections respectively for the input channels.

$V_{\text{CCO}}$  and  $\text{GNDO}$  are supply and ground connections respectively for the output channels.



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## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (December 2016) to Revision D	Page
• Updated the <i>Safety-Related Certifications</i> table .....	9
• Changed the minimum CMTI from 40 to 85 in all <i>Electrical Characteristics</i> tables .....	10

Changes from Revision B (October 2016) to Revision C	Page
• Changed the <i>Regulatory Information</i> table to <i>Safety-Related Certifications</i> and updated content .....	9
• Changed the certifications from planned to certified in the <i>Safety-Related Certifications</i> table .....	9

Changes from Revision A (June 2016) to Revision B	Page
• Changed <i>Feature</i> From: High CMTI: $\pm 75$ kV/ $\mu$ s Typical To: High CMTI: $\pm 100$ kV/ $\mu$ s Typical .....	1
• Changed <i>Feature</i> From: All Certifications are Planned To: 'VDE, UL, and TUV Certifications for DW Package Complete; All Other Certifications are Planned' .....	1
• Changed the unit value of CLR and CPG From: $\mu$ m To: mm in <i>Insulation Specifications</i> .....	8
• Changed From: "Plan to certify" To: "Certified" in column VDE of <i>Safety-Related Certifications</i> .....	9
• Added a conditions statement to <i>Safety-Related Certifications</i> .....	9
• Changed From: "Plan to certify" To: "Certified" in column UL of <i>Safety-Related Certifications</i> .....	9
• Changed From: "Plan to certify" To: "Certified" in column TUV of <i>Safety-Related Certifications</i> .....	9
• Changed From: "Certification Planned" To: 'Certificate number: 40040142' in column VDE of <i>Safety-Related Certifications</i> .....	9
• Changed From: "Certification Planned" To: "File number: E181974" in column VDE of <i>Safety-Related Certifications</i> .....	9

• Changed From: "Certification Planned" To: "Client ID number: 77311" in column TUV of <a href="#">Safety-Related Certifications</a> .....	9
• Changed the CMTI TYP value From: 75 kV/μs To: 100 kV/μs in the <a href="#">Electrical Characteristics—5-V Supply</a> .....	10
• Changed the CMTI TYP value From: 75 kV/μs To: 100 kV/μs in the <a href="#">Electrical Characteristics—3.3-V Supply</a> .....	12
• Changed the CMTI TYP value From: 75 kV/μs To: 100 kV/μs in the <a href="#">Electrical Characteristics—2.5-V Supply</a> .....	14
• Changed the $t_{DO}$ TYP value From: 6 μs To: 0.1 μs and the MAX value From: 9 μs To: 0.3 μs in the <a href="#">Switching Characteristics—5-V Supply</a> .....	16
• Changed the $t_{DO}$ TYP value From: 6 μs To: 0.1 μs and the MAX value From: 9 μs To: 0.3 μs in the <a href="#">Switching Characteristics—3.3-V Supply</a> .....	16
• Changed the $t_{DO}$ TYP value From: 6 μs To: 0.1 μs and the MAX value From: 9 μs To: 0.3 μs in the <a href="#">Switching Characteristics—2.5-V Supply</a> .....	17
• Added Note B to <a href="#">Figure 17</a> .....	22
• Changed the <a href="#">Design Requirements</a> paragraph .....	27
• Replaced the <a href="#">Power Supply Recommendations</a> section .....	28

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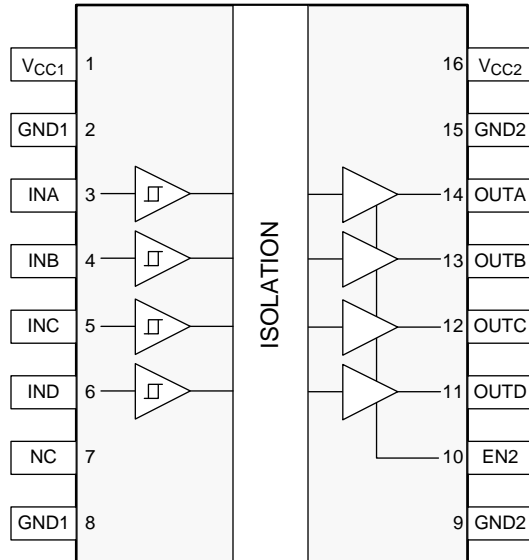
**Changes from Original (March 2016) to Revision A**
**Page**

• Changed the device status From: Preview To; Production. ....	1
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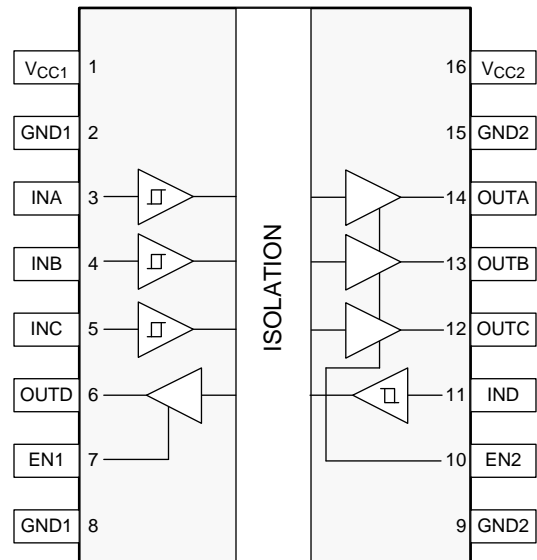
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## 5 Pin Configuration and Functions

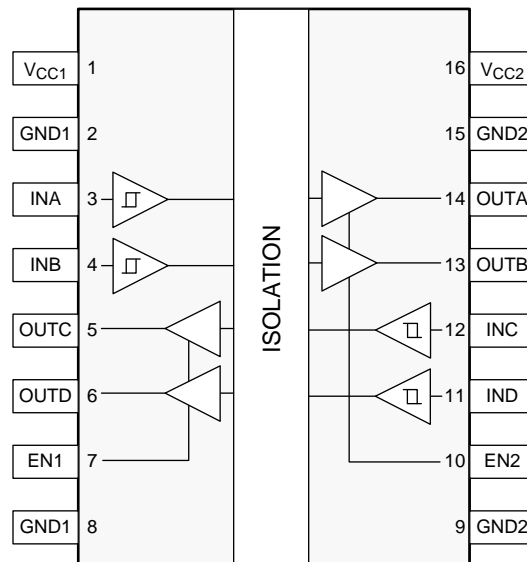
**ISO7740 DW and DBQ Packages**  
16-Pin SOIC-WB and QSOP  
Top View



**ISO7741 DW and DBQ Packages**  
16-Pin SOIC-WB and QSOP  
Top View



**ISO7742 DW and DBQ Packages**  
16-Pin SOIC-WB and QSOP  
Top View



**Pin Functions**

NAME	PIN			I/O	DESCRIPTION
	ISO7740	ISO7741	ISO7742		
EN1	—	7	7	I	Output enable 1. Output pins on side 1 are enabled when EN1 is high or open and in high-impedance state when EN1 is low.
EN2	10	10	10	I	Output enable 2. Output pins on side 2 are enabled when EN2 is high or open and in high-impedance state when EN2 is low.
GND1	2	2	2	—	Ground connection for $V_{CC1}$
	8	8	8		
GND2	9	9	9	—	Ground connection for $V_{CC2}$
	15	15	15		
INA	3	3	3	I	Input, channel A
INB	4	4	4	I	Input, channel B
INC	5	5	12	I	Input, channel C
IND	6	11	11	I	Input, channel D
NC	7	—	—	—	Not connected
OUTA	14	14	14	O	Output, channel A
OUTB	13	13	13	O	Output, channel B
OUTC	12	12	5	O	Output, channel C
OUTD	11	6	6	O	Output, channel D
$V_{CC1}$	1	1	1	—	Power supply, side 1
$V_{CC2}$	16	16	16	—	Power supply, side 2

## 6 Specifications

### 6.1 Absolute Maximum Ratings

 See <sup>(1)</sup>

		MIN	MAX	UNIT
$V_{CC1}, V_{CC2}$	Supply voltage <sup>(2)</sup>	-0.5	6	V
V	Voltage at INx, OUTx, ENx	-0.5	$V_{CCX} + 0.5^{(3)}$	V
$I_O$	Output current	-15	15	mA
$T_J$	Junction temperature		150	°C
$T_{stg}$	Storage temperature	-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values except differential I/O bus voltages are with respect to the local ground terminal (GND1 or GND2) and are peak voltage values.
- (3) Maximum voltage must not exceed 6 V.

### 6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±6000
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	±1500
			V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
$V_{CC1}, V_{CC2}$	Supply voltage	2.25		5.5	V
$V_{CC(UVLO+)}$	UVLO threshold when supply voltage is rising		2	2.25	V
$V_{CC(UVLO-)}$	UVLO threshold when supply voltage is falling	1.7	1.8		V
$V_{HYS(UVLO)}$	Supply voltage UVLO hysteresis	100	200		mV
$I_{OH}$	High-level output current	$V_{CCO}^{(1)} = 5\text{ V}$		-4	mA
		$V_{CCO} = 3.3\text{ V}$		-2	
		$V_{CCO} = 2.5\text{ V}$		-1	
$I_{OL}$	Low-level output current	$V_{CCO} = 5\text{ V}$		4	mA
		$V_{CCO} = 3.3\text{ V}$		2	
		$V_{CCO} = 2.5\text{ V}$		1	
$V_{IH}$	High-level input voltage	$0.7 \times V_{CCI}^{(1)}$		$V_{CCI}$	V
$V_{IL}$	Low-level input voltage	0		$0.3 \times V_{CCI}$	V
DR	Data rate	0		100	Mbps
$T_A$	Ambient temperature	-55	25	125	°C

- (1)  $V_{CCI}$  = Input-side  $V_{CC}$ ;  $V_{CCO}$  = Output-side  $V_{CC}$ .

## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		ISO774x		UNIT
		DW (SOIC)	DBQ (QSOP)	
		16 Pins	16 Pins	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	83.4	109	°C/W
R <sub>θJC(top)</sub>	Junction-to-case(top) thermal resistance	46	54.4	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	48	51.9	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	19.1	14.2	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	47.5	51.4	°C/W
R <sub>θJC(bottom)</sub>	Junction-to-case(bottom) thermal resistance	—	—	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report (SPRA953).

## 6.5 Power Rating

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>ISO7740</b>						
P <sub>D</sub>	Maximum power dissipation	V <sub>CC1</sub> = V <sub>CC2</sub> = 5.5 V, T <sub>J</sub> = 150°C, C <sub>L</sub> = 15 pF, Input a 50-MHz 50% duty cycle square wave			200	mW
P <sub>D1</sub>	Maximum power dissipation by side-1				40	mW
P <sub>D2</sub>	Maximum power dissipation by side-2				160	mW
<b>ISO7741</b>						
P <sub>D</sub>	Maximum power dissipation	V <sub>CC1</sub> = V <sub>CC2</sub> = 5.5 V, T <sub>J</sub> = 150°C, C <sub>L</sub> = 15 pF, Input a 50-MHz 50% duty cycle square wave			200	mW
P <sub>D1</sub>	Maximum power dissipation by side-1				50	mW
P <sub>D2</sub>	Maximum power dissipation by side-2				150	mW
<b>ISO7742</b>						
P <sub>D</sub>	Maximum power dissipation	V <sub>CC1</sub> = V <sub>CC2</sub> = 5.5 V, T <sub>J</sub> = 150°C, C <sub>L</sub> = 15 pF, Input a 50-MHz 50% duty cycle square wave			200	mW
P <sub>D1</sub>	Maximum power dissipation by side-1				100	mW
P <sub>D2</sub>	Maximum power dissipation by side-2				100	mW

## 6.6 Insulation Specifications

PARAMETER		TEST CONDITIONS	VALUE		UNIT
			DW-16	DBQ-16	
CLR	External clearance <sup>(1)</sup>	Shortest terminal-to-terminal distance through air	>8	>3.7	mm
CPG	External creepage <sup>(1)</sup>	Shortest terminal-to-terminal distance across the package surface	>8	>3.7	mm
DTI	Distance through the insulation	Minimum internal gap (internal clearance)	>21	>21	μm
CTI	Comparative tracking index	DIN EN 60112 (VDE 0303-11); IEC 60112	>600	>600	V
	Material group	According to IEC 60664-1	I	I	
	Overvoltage category per IEC 60664-1	Rated mains voltage ≤ 300 V <sub>RMS</sub>	I-IV	I-III	
		Rated mains voltage ≤ 600 V <sub>RMS</sub>	I-IV	n/a	
		Rated mains voltage ≤ 1000 V <sub>RMS</sub>	I-III	n/a	
<b>DIN V VDE V 0884-10 (VDE V 0884-10):2006-12<sup>(2)</sup></b>					
V <sub>IORM</sub>	Maximum repetitive peak isolation voltage	AC voltage (bipolar)	1414	566	V <sub>PK</sub>
V <sub>IOWM</sub>	Maximum isolation working voltage	AC voltage; Time dependent dielectric breakdown (TDDB) Test	1000	400	V <sub>RMS</sub>
		DC voltage	1414	566	V <sub>DC</sub>
V <sub>IOTM</sub>	Maximum transient isolation voltage	V <sub>TEST</sub> = V <sub>IOTM</sub> t = 60 s (qualification) t = 1 s (100% production)	8000	3600	V <sub>PK</sub>
V <sub>IOSM</sub>	Maximum surge isolation voltage <sup>(3)</sup>	Test method per IEC 60065, 1.2/50 μs waveform, V <sub>TEST</sub> = 1.6 × V <sub>IOSM</sub> (qualification)	8000	4000	V <sub>PK</sub>
Q <sub>pd</sub>	Apparent charge <sup>(4)</sup>	Method a, After Input/Output safety test subgroup 2/3, V <sub>ini</sub> = V <sub>IOTM</sub> , t <sub>ini</sub> = 60 s; V <sub>pd(m)</sub> = 1.2 × V <sub>IORM</sub> , t <sub>m</sub> = 10 s	≤5	≤5	pC
		Method a, After environmental tests subgroup 1, V <sub>ini</sub> = V <sub>IOTM</sub> , t <sub>ini</sub> = 60 s; V <sub>pd(m)</sub> = 1.6 × V <sub>IORM</sub> , t <sub>m</sub> = 10 s	≤5	≤5	
		Method b1; At routine test (100% production) and preconditioning (type test) V <sub>ini</sub> = V <sub>IOTM</sub> , t <sub>ini</sub> = 1 s; V <sub>pd(m)</sub> = 1.875 × V <sub>IORM</sub> , t <sub>m</sub> = 1 s	≤5	≤5	
C <sub>IO</sub>	Barrier capacitance, input to output <sup>(5)</sup>	V <sub>IO</sub> = 0.4 × sin(2πft), f = 1 MHz	~1	~1	pF
R <sub>IO</sub>	Isolation resistance <sup>(5)</sup>	V <sub>IO</sub> = 500 V, T <sub>A</sub> = 25°C	>10 <sup>12</sup>	>10 <sup>12</sup>	Ω
		V <sub>IO</sub> = 500 V, 100°C ≤ T <sub>A</sub> ≤ 125°C	>10 <sup>11</sup>	>10 <sup>11</sup>	
		V <sub>IO</sub> = 500 V at T <sub>S</sub> = 150°C	>10 <sup>9</sup>	>10 <sup>9</sup>	
	Pollution degree		2	2	
	Climatic category		55/125/21	55/125/21	
<b>UL 1577</b>					
V <sub>ISO</sub>	Maximum withstanding isolation voltage	V <sub>TEST</sub> = V <sub>ISO</sub> , t = 60 s (qualification), V <sub>TEST</sub> = 1.2 × V <sub>ISO</sub> , t = 1 s (100% production)	5000	2500	V <sub>RMS</sub>

- Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed-circuit board do not reduce this distance. Creepage and clearance on a printed-circuit board become equal in certain cases. Techniques such as inserting grooves and/or ribs on a printed circuit board are used to help increase these specifications.
- This coupler is suitable for *safe electrical insulation* only within the safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.
- Testing is carried out in air or oil to determine the intrinsic surge immunity of the isolation barrier.
- Apparent charge is electrical discharge caused by a partial discharge (pd).
- All pins on each side of the barrier tied together creating a two-terminal device.



## 6.7 Safety-Related Certifications

DW package devices certified. All other certifications are planned.

VDE	CSA	UL	CQC	TUV
Certified according to DIN V VDE V 0884-10 (VDE V 0884-10):2006-12	Certified under CSA Component Acceptance Notice 5A, IEC 60950-1 and IEC 60601-1	Certified according to UL 1577 Component Recognition Program	Certified according to GB 4943.1-2011	Certified according to EN 61010-1:2010 (3rd Ed) and EN 60950-1:2006/A11:2009/A1:2010/A12:2011/A2:2013
Maximum transient isolation voltage, 8000 V <sub>PK</sub> (DW-16) and 3600 V <sub>PK</sub> (DBQ-16); Maximum repetitive peak isolation voltage, 1414 V <sub>PK</sub> (DW-16, Reinforced) and 566 V <sub>PK</sub> (DBQ-16); Maximum surge isolation voltage, 8000 V <sub>PK</sub> (DW-16) and 4000 V <sub>PK</sub> (DBQ-16)	Reinforced insulation per CSA 60950-1-07+A1+A2 and IEC 60950-1 2nd Ed., 800 V <sub>RMS</sub> (DW-16) and 370 V <sub>RMS</sub> (DBQ-16) max working voltage (pollution degree 2, material group I); 2 MOPP (Means of Patient Protection) per CSA 60601-1:14 and IEC 60601-1 Ed. 3.1, 250 V <sub>RMS</sub> (DW-16) max working voltage	<b>DW-16:</b> Single protection, 5000 V <sub>RMS</sub> ; <b>DBQ-16:</b> Single protection, 2500 V <sub>RMS</sub>	<b>DW-16:</b> Reinforced Insulation, Altitude ≤ 5000 m, Tropical Climate, 400 V <sub>RMS</sub> maximum working voltage; <b>DBQ-16:</b> Basic Insulation, Altitude ≤ 5000 m, Tropical Climate, 250 V <sub>RMS</sub> maximum working voltage	5000 V <sub>RMS</sub> (DW-16) and 2500 V <sub>RMS</sub> (DBQ-16) Reinforced insulation per EN 61010-1:2010 (3rd Ed) up to working voltage of 600 V <sub>RMS</sub> (DW-16) and 300 V <sub>RMS</sub> (DBQ-16) 5000 V <sub>RMS</sub> (DW-16) and 2500 V <sub>RMS</sub> (DBQ-16) Reinforced insulation per EN 60950-1:2006/A11:2009/A1:2010/A12:2011/A2:2013 up to working voltage of 800 V <sub>RMS</sub> (DW-16) and 370 V <sub>RMS</sub> (DBQ-16)
Certificate number: 40040142	Master contract number: 220991	File number: E181974	Certificate number: CQC15001121716	Client ID number: 77311

## 6.8 Safety Limiting Values

Safety limiting<sup>(1)</sup> intends to minimize potential damage to the isolation barrier upon failure of input or output circuitry. A failure of the I/O can allow low resistance to ground or the supply and, without current limiting, dissipate sufficient power to overheat the die and damage the isolation barrier potentially leading to secondary system failures.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>DW-16 PACKAGE</b>						
I <sub>S</sub>	Safety input, output, or supply current	R <sub>θJA</sub> = 83.4 °C/W, V <sub>I</sub> = 5.5 V, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C, see <a href="#">Figure 1</a>			273	mA
		R <sub>θJA</sub> = 83.4 °C/W, V <sub>I</sub> = 3.6 V, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C, see <a href="#">Figure 1</a>			416	
		R <sub>θJA</sub> = 83.4 °C/W, V <sub>I</sub> = 2.75 V, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C, see <a href="#">Figure 1</a>			545	
P <sub>S</sub>	Safety input, output, or total power	R <sub>θJA</sub> = 83.4 °C/W, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C, see <a href="#">Figure 3</a>			1499	mW
T <sub>S</sub>	Maximum safety temperature				150	°C
<b>DBQ-16 PACKAGE</b>						
I <sub>S</sub>	Safety input, output, or supply current	R <sub>θJA</sub> = 109 °C/W, V <sub>I</sub> = 5.5 V, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C, see <a href="#">Figure 2</a>			209	mA
		R <sub>θJA</sub> = 109 °C/W, V <sub>I</sub> = 3.6 V, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C, see <a href="#">Figure 2</a>			319	
		R <sub>θJA</sub> = 109 °C/W, V <sub>I</sub> = 2.75 V, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C, see <a href="#">Figure 2</a>			417	
P <sub>S</sub>	Safety input, output, or total power	R <sub>θJA</sub> = 109 °C/W, T <sub>J</sub> = 150°C, T <sub>A</sub> = 25°C, see <a href="#">Figure 4</a>			1147	mW
T <sub>S</sub>	Maximum safety temperature				150	°C

- (1) The maximum safety temperature is the maximum junction temperature specified for the device. The power dissipation and junction-to-air thermal impedance of the device installed in the application hardware determines the junction temperature. The assumed junction-to-air thermal resistance in the [Thermal Information](#) is that of a device installed on a High-K test board for leaded Surface Mount Packages. The power is the recommended maximum input voltage times the current. The junction temperature is then the ambient temperature plus the power times the junction-to-air thermal resistance

## 6.9 Electrical Characteristics—5-V Supply

 $V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{OH}$	High-level output voltage $I_{OH} = -4\text{ mA}$ ; see <a href="#">Figure 15</a>	$V_{CCO}^{(1)} - 0.4$	4.8		V
$V_{OL}$	Low-level output voltage $I_{OL} = 4\text{ mA}$ ; see <a href="#">Figure 15</a>		0.2	0.4	V
$V_{IT+(IN)}$	Rising input voltage threshold		$0.6 \times V_{CCI}$	$0.7 \times V_{CCI}$	V
$V_{IT-(IN)}$	Falling input voltage threshold	$0.3 \times V_{CCI}$	$0.4 \times V_{CCI}$		V
$V_{I(HYS)}$	Input threshold voltage hysteresis	$0.1 \times V_{CCI}$	$0.2 \times V_{CCI}$		V
$I_{IH}$	High-level input current $V_{IH} = V_{CCI}^{(1)}$ at INx or ENx			10	$\mu\text{A}$
$I_{IL}$	Low-level input current $V_{IL} = 0\text{ V}$ at INx or ENx	-10			$\mu\text{A}$
CMTI	Common-mode transient immunity $V_I = V_{CCI}$ or 0 V, $V_{CM} = 1200\text{ V}$ ; see <a href="#">Figure 18</a>	85	100		kV/ $\mu\text{s}$
$C_I$	Input Capacitance <sup>(2)</sup> $V_I = V_{CC}/2 + 0.4 \times \sin(2\pi ft)$ , $f = 1\text{ MHz}$ , $V_{CC} = 5\text{ V}$		2		pF

(1)  $V_{CCI}$  = Input-side  $V_{CC}$ ;  $V_{CCO}$  = Output-side  $V_{CC}$ .

(2) Measured from input pin to ground.

## 6.10 Supply Current Characteristics—5-V Supply

 $V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted).

PARAMETER	TEST CONDITIONS		SUPPLY CURRENT	MIN	TYP	MAX	UNIT			
<b>ISO7740</b>										
Supply current - Disable	EN2 = 0 V; $V_I = V_{CC1}$ (ISO7740); $V_I = 0\text{ V}$ (ISO7740 with F suffix)		$I_{CC1}$		1.2	1.6	mA			
			$I_{CC2}$		0.3	0.5				
	EN2 = 0 V; $V_I = 0\text{ V}$ (ISO7740); $V_I = V_{CC1}$ (ISO7740 with F suffix)		$I_{CC1}$		5.5	7.8				
			$I_{CC2}$		0.3	0.5				
Supply current - DC signal	EN2 = $V_{CC2}$ ; $V_I = V_{CC1}$ (ISO7740); $V_I = 0\text{ V}$ (ISO7740 with F suffix)		$I_{CC1}$		1.2	1.6				
			$I_{CC2}$		2	3.2				
	EN2 = $V_{CC2}$ ; $V_I = 0\text{ V}$ (ISO7740); $V_I = V_{CC1}$ (ISO7740 with F suffix)		$I_{CC1}$		5.5	7.8				
			$I_{CC2}$		2.2	3.6				
Supply current - AC signal	All channels switching with square wave clock input; $C_L = 15\text{ pF}$		1 Mbps		$I_{CC1}$		3.3	4.7		
					$I_{CC2}$		2.3	3.6		
			10 Mbps		$I_{CC1}$		3.4	4.8		
					$I_{CC2}$		4.2	5.8		
			100 Mbps		$I_{CC1}$		3.8	5.7		
					$I_{CC2}$		22.7	28		
<b>ISO7741</b>										
Supply current - Disable	EN1 = EN2 = 0 V; $V_I = V_{CCI}^{(1)}$ (ISO7741); $V_I = 0\text{ V}$ (ISO7741 with F suffix)		$I_{CC1}$		1	1.5	mA			
			$I_{CC2}$		0.8	1.1				
	EN1 = EN2 = 0 V; $V_I = 0\text{ V}$ (ISO7741); $V_I = V_{CCI}$ (ISO7741 with F suffix)		$I_{CC1}$		4.3	6.3				
			$I_{CC2}$		1.8	2.7				
Supply current - DC signal	EN1 = EN2 = $V_{CCI}$ ; $V_I = V_{CCI}$ (ISO7741); $V_I = 0\text{ V}$ (ISO7741 with F suffix)		$I_{CC1}$		1.5	2.3				
			$I_{CC2}$		2	3				
	EN1 = EN2 = $V_{CCI}$ ; $V_I = 0\text{ V}$ (ISO7741); $V_I = V_{CCI}$ (ISO7741 with F suffix)		$I_{CC1}$		4.8	6.8				
			$I_{CC2}$		3.2	4.9				
Supply current - AC signal	All channels switching with square wave clock input; $C_L = 15\text{ pF}$		1 Mbps		$I_{CC1}$		3.2	4.6		
					$I_{CC2}$		2.8	4.1		
			10 Mbps		$I_{CC1}$		3.7	5.2		
					$I_{CC2}$		4.2	5.7		
			100 Mbps		$I_{CC1}$		8.6	11.3		
					$I_{CC2}$		18	22		
<b>ISO7742</b>										
Supply current - Disable	EN1 = EN2 = 0 V; $V_I = V_{CCI}$ (ISO7742); $V_I = 0\text{ V}$ (ISO7742 with F suffix)		$I_{CC1}, I_{CC2}$			0.9	1.3	mA		
	EN1 = EN2 = 0 V; $V_I = 0\text{ V}$ (ISO7742); $V_I = V_{CCI}$ (ISO7742 with F suffix)		$I_{CC1}, I_{CC2}$			3	4.6			
Supply current - DC signal	EN1 = EN2 = $V_{CCI}$ ; $V_I = V_{CCI}$ (ISO7742); $V_I = 0\text{ V}$ (ISO7742 with F suffix)		$I_{CC1}, I_{CC2}$			1.7	2.7			
	EN1 = EN2 = $V_{CCI}$ ; $V_I = 0\text{ V}$ (ISO7742); $V_I = V_{CCI}$ (ISO7742 with F suffix)		$I_{CC1}, I_{CC2}$			4	5.9			
Supply current - AC signal	All channels switching with square wave clock input; $C_L = 15\text{ pF}$		1 Mbps		$I_{CC1}, I_{CC2}$				3	4.4
			10 Mbps		$I_{CC1}, I_{CC2}$				4	5.5
			100 Mbps		$I_{CC1}, I_{CC2}$				13.4	17

 (1)  $V_{CCI}$  = Input-side  $V_{CC}$

## 6.11 Electrical Characteristics—3.3-V Supply

 $V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{OH}$	High-level output voltage	$I_{OH} = -2 \text{ mA}$ ; see <a href="#">Figure 15</a>	$V_{CCO}^{(1)} - 0.3$	3.2		V
$V_{OL}$	Low-level output voltage	$I_{OL} = 2 \text{ mA}$ ; see <a href="#">Figure 15</a>		0.1	0.3	V
$V_{IT+(IN)}$	Rising input voltage threshold			$0.6 \times V_{CCI}$	$0.7 \times V_{CCI}$	V
$V_{IT-(IN)}$	Falling input voltage threshold		$0.3 \times V_{CCI}$	$0.4 \times V_{CCI}$		V
$V_{I(HYS)}$	Input threshold voltage hysteresis		$0.1 \times V_{CCI}$	$0.2 \times V_{CCI}$		V
$I_{IH}$	High-level input current	$V_{IH} = V_{CCI}^{(1)}$ at INx or ENx			10	$\mu\text{A}$
$I_{IL}$	Low-level input current	$V_{IL} = 0 \text{ V}$ at INx or ENx	-10			$\mu\text{A}$
CMTI	Common-mode transient immunity	$V_I = V_{CCI}$ or $0 \text{ V}$ , $V_{CM} = 1200 \text{ V}$ ; see <a href="#">Figure 18</a>	85	100		$\text{kV}/\mu\text{s}$

(1)  $V_{CCI}$  = Input-side  $V_{CC}$ ;  $V_{CCO}$  = Output-side  $V_{CC}$ .

## 6.12 Supply Current Characteristics—3.3-V Supply

 $V_{CC1} = V_{CC2} = 3.3\text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted).

PARAMETER	TEST CONDITIONS		SUPPLY CURRENT	MIN	TYP	MAX	UNIT
<b>ISO7740</b>							
Supply current - Disable	EN2 = 0 V; V <sub>I</sub> = V <sub>CC1</sub> (ISO7740); V <sub>I</sub> = 0 V (ISO7740 with F suffix)		I <sub>CC1</sub>		1.2	1.6	mA
			I <sub>CC2</sub>		0.3	0.5	
	EN2 = 0 V; V <sub>I</sub> = 0 V (ISO7740); V <sub>I</sub> = V <sub>CC1</sub> (ISO7740 with F suffix)		I <sub>CC1</sub>		5.5	7.8	
			I <sub>CC2</sub>		0.3	0.5	
Supply current - DC signal	EN2 = V <sub>CC2</sub> ; V <sub>I</sub> = V <sub>CC1</sub> (ISO7740); V <sub>I</sub> = 0 V (ISO7740 with F suffix)		I <sub>CC1</sub>		1.2	1.6	
			I <sub>CC2</sub>		1.9	3.2	
	EN2 = V <sub>CC2</sub> ; V <sub>I</sub> = 0 V (ISO7740); V <sub>I</sub> = V <sub>CC1</sub> (ISO7740 with F suffix)		I <sub>CC1</sub>		5.5	7.8	
			I <sub>CC2</sub>		2.2	3.6	
Supply current - AC signal	All channels switching with square wave clock input; C <sub>L</sub> = 15 pF	1 Mbps	I <sub>CC1</sub>		3.3	4.7	
			I <sub>CC2</sub>		2.2	3.6	
		10 Mbps	I <sub>CC1</sub>		3.4	4.8	
			I <sub>CC2</sub>		3.6	5	
		100 Mbps	I <sub>CC1</sub>		3.3	5.5	
			I <sub>CC2</sub>		17	20	
<b>ISO7741</b>							
Supply current - Disable	EN1 = EN2 = 0 V; V <sub>I</sub> = V <sub>CC1</sub> <sup>(1)</sup> (ISO7741); V <sub>I</sub> = 0 V (ISO7741 with F suffix)		I <sub>CC1</sub>		1	1.5	mA
			I <sub>CC2</sub>		0.8	1.1	
	EN1 = EN2 = 0 V; V <sub>I</sub> = 0 V (ISO7741); V <sub>I</sub> = V <sub>CC1</sub> (ISO7741 with F suffix)		I <sub>CC1</sub>		4.3	6.3	
			I <sub>CC2</sub>		1.9	2.7	
Supply current - DC signal	EN1 = EN2 = V <sub>CC1</sub> ; V <sub>I</sub> = V <sub>CC1</sub> (ISO7741); V <sub>I</sub> = 0 V (ISO7741 with F suffix)		I <sub>CC1</sub>		1.5	2.3	
			I <sub>CC2</sub>		2	3	
	EN1 = EN2 = V <sub>CC1</sub> ; V <sub>I</sub> = 0 V (ISO7741); V <sub>I</sub> = V <sub>CC1</sub> (ISO7741 with F suffix)		I <sub>CC1</sub>		4.8	6.8	
			I <sub>CC2</sub>		3.2	4.9	
Supply current - AC signal	All channels switching with square wave clock input; C <sub>L</sub> = 15 pF	1 Mbps	I <sub>CC1</sub>		3.2	4.6	
			I <sub>CC2</sub>		2.7	4.1	
		10 Mbps	I <sub>CC1</sub>		3.5	5	
			I <sub>CC2</sub>		3.7	5.2	
		100 Mbps	I <sub>CC1</sub>		6.8	9.3	
			I <sub>CC2</sub>		13.7	16.4	
<b>ISO7742</b>							
Supply current - Disable	EN1 = EN2 = 0 V; V <sub>I</sub> = V <sub>CC1</sub> (ISO7742); V <sub>I</sub> = 0 V (ISO7742 with F suffix)		I <sub>CC1</sub> , I <sub>CC2</sub>		0.9	1.3	mA
	EN1 = EN2 = 0 V; V <sub>I</sub> = 0 V (ISO7742); V <sub>I</sub> = V <sub>CC1</sub> (ISO7742 with F suffix)		I <sub>CC1</sub> , I <sub>CC2</sub>		3	4.6	
Supply current - DC signal	EN1 = EN2 = V <sub>CC1</sub> ; V <sub>I</sub> = V <sub>CC1</sub> (ISO7742); V <sub>I</sub> = 0 V (ISO7742 with F suffix)		I <sub>CC1</sub> , I <sub>CC2</sub>		1.7	2.7	
	EN1 = EN2 = V <sub>CC1</sub> ; V <sub>I</sub> = 0 V (ISO7742); V <sub>I</sub> = V <sub>CC1</sub> (ISO7742 with F suffix)		I <sub>CC1</sub> , I <sub>CC2</sub>		4	5.9	
Supply current - AC signal	All channels switching with square wave clock input; C <sub>L</sub> = 15 pF	1 Mbps	I <sub>CC1</sub> , I <sub>CC2</sub>		2.9	4.3	
		10 Mbps	I <sub>CC1</sub> , I <sub>CC2</sub>		3.6	5.1	
		100 Mbps	I <sub>CC1</sub> , I <sub>CC2</sub>		10.3	13	

 (1) V<sub>CC1</sub> = Input-side V<sub>CC</sub>

### 6.13 Electrical Characteristics—2.5-V Supply

 $V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{OH}$	High-level output voltage	$I_{OH} = -1 \text{ mA}$ ; see <a href="#">Figure 15</a>	$V_{CCO}^{(1)} - 0.2$	2.45		V
$V_{OL}$	Low-level output voltage	$I_{OL} = 1 \text{ mA}$ ; see <a href="#">Figure 15</a>		0.05	0.2	V
$V_{IT+(IN)}$	Rising input voltage threshold			$0.6 \times V_{CCI}$	$0.7 \times V_{CCI}$	V
$V_{IT-(IN)}$	Falling input voltage threshold		$0.3 \times V_{CCI}$	$0.4 \times V_{CCI}$		V
$V_{I(HYS)}$	Input threshold voltage hysteresis		$0.1 \times V_{CCI}$	$0.2 \times V_{CCI}$		V
$I_{IH}$	High-level input current	$V_{IH} = V_{CCI}^{(1)}$ at INx or ENx			10	$\mu\text{A}$
$I_{IL}$	Low-level input current	$V_{IL} = 0 \text{ V}$ at INx or ENx	-10			$\mu\text{A}$
CMTI	Common-mode transient immunity	$V_I = V_{CCI}$ or $0 \text{ V}$ , $V_{CM} = 1200 \text{ V}$ ; see <a href="#">Figure 18</a>	85	100		$\text{kV}/\mu\text{s}$

(1)  $V_{CCI}$  = Input-side  $V_{CC}$ ;  $V_{CCO}$  = Output-side  $V_{CC}$ .

## 6.14 Supply Current Characteristics—2.5-V Supply

 $V_{CC1} = V_{CC2} = 2.5\text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted).

PARAMETER	TEST CONDITIONS		SUPPLY CURRENT	MIN	TYP	MAX	UNIT	
<b>ISO7740</b>								
Supply current - Disable	EN2 = 0 V; V <sub>I</sub> = V <sub>CC1</sub> (ISO7740); V <sub>I</sub> = 0 V (ISO7740 with F suffix)		I <sub>CC1</sub>		1.2	1.6	mA	
			I <sub>CC2</sub>		0.3	0.5		
	EN2 = 0 V; V <sub>I</sub> = 0 V (ISO7740); V <sub>I</sub> = V <sub>CC1</sub> (ISO7740 with F suffix)		I <sub>CC1</sub>		5.5	7.8		
			I <sub>CC2</sub>		0.3	0.5		
Supply current - DC signal	EN2 = V <sub>CC2</sub> ; V <sub>I</sub> = V <sub>CC1</sub> (ISO7740); V <sub>I</sub> = 0 V (ISO7740 with F suffix)		I <sub>CC1</sub>		1.2	1.6		
			I <sub>CC2</sub>		1.9	3.2		
	EN2 = V <sub>CC2</sub> ; V <sub>I</sub> = 0 V (ISO7740); V <sub>I</sub> = V <sub>CC1</sub> (ISO7740 with F suffix)		I <sub>CC1</sub>		5.4	7.8		
			I <sub>CC2</sub>		2.2	3.6		
Supply current - AC signal	All channels switching with square wave clock input; C <sub>L</sub> = 15 pF		1 Mbps	I <sub>CC1</sub>		3.3	4.7	
				I <sub>CC2</sub>		2.2	3.5	
			10 Mbps	I <sub>CC1</sub>		3.4	4.8	
				I <sub>CC2</sub>		3.2	4.7	
			100 Mbps	I <sub>CC1</sub>		3.2	5.4	
				I <sub>CC2</sub>		13	17	
<b>ISO7741</b>								
Supply current - Disable	EN1 = EN2 = 0 V; V <sub>I</sub> = V <sub>CCI</sub> <sup>(1)</sup> (ISO7741); V <sub>I</sub> = 0 V (ISO7741 with F suffix)		I <sub>CC1</sub>		1	1.5	mA	
			I <sub>CC2</sub>		0.8	1.1		
	EN1 = EN2 = 0 V; V <sub>I</sub> = 0 V (ISO7741); V <sub>I</sub> = V <sub>CCI</sub> (ISO7741 with F suffix)		I <sub>CC1</sub>		4.3	6.3		
			I <sub>CC2</sub>		1.8	2.7		
Supply current - DC signal	EN1 = EN2 = V <sub>CCI</sub> ; V <sub>I</sub> = V <sub>CCI</sub> (ISO7741); V <sub>I</sub> = 0 V (ISO7741 with F suffix)		I <sub>CC1</sub>		1.4	2.3		
			I <sub>CC2</sub>		2	3		
	EN1 = EN2 = V <sub>CCI</sub> ; V <sub>I</sub> = 0 V (ISO7741); V <sub>I</sub> = V <sub>CCI</sub> (ISO7741 with F suffix)		I <sub>CC1</sub>		4.7	6.8		
			I <sub>CC2</sub>		3.2	4.9		
Supply current - AC signal	All channels switching with square wave clock input; C <sub>L</sub> = 15 pF		1 Mbps	I <sub>CC1</sub>		3.1	4.6	
				I <sub>CC2</sub>		2.7	4	
			10 Mbps	I <sub>CC1</sub>		3.4	4.9	
				I <sub>CC2</sub>		3.5	4.9	
			100 Mbps	I <sub>CC1</sub>		5.6	8.3	
				I <sub>CC2</sub>		10.8	13.8	
<b>ISO7742</b>								
Supply current - Disable	EN1 = EN2 = 0 V; V <sub>I</sub> = V <sub>CCI</sub> (ISO7742); V <sub>I</sub> = 0 V (ISO7742 with F suffix)		I <sub>CC1</sub> , I <sub>CC2</sub>		0.9	1.3	mA	
	EN1 = EN2 = 0 V; V <sub>I</sub> = 0 V (ISO7742); V <sub>I</sub> = V <sub>CCI</sub> (ISO7742 with F suffix)		I <sub>CC1</sub> , I <sub>CC2</sub>		3	4.6		
Supply current - DC signal	EN1 = EN2 = V <sub>CCI</sub> ; V <sub>I</sub> = V <sub>CCI</sub> (ISO7742); V <sub>I</sub> = 0 V (ISO7742 with F suffix)		I <sub>CC1</sub> , I <sub>CC2</sub>		1.7	2.7		
	EN1 = EN2 = V <sub>CCI</sub> ; V <sub>I</sub> = 0 V (ISO7742); V <sub>I</sub> = V <sub>CCI</sub> (ISO7742 with F suffix)		I <sub>CC1</sub> , I <sub>CC2</sub>		4	5.9		
Supply current - AC signal	All channels switching with square wave clock input; C <sub>L</sub> = 15 pF		1 Mbps	I <sub>CC1</sub> , I <sub>CC2</sub>		2.9		4.3
			10 Mbps	I <sub>CC1</sub> , I <sub>CC2</sub>		3.4		4.9
			100 Mbps	I <sub>CC1</sub> , I <sub>CC2</sub>		8.3	11.5	

 (1) V<sub>CCI</sub> = Input-side V<sub>CC</sub>

## 6.15 Switching Characteristics—5-V Supply

 $V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
$t_{PLH}$ , $t_{PHL}$	Propagation delay time	See Figure 15	6	10.7	16	ns	
PWD	Pulse width distortion <sup>(1)</sup> $ t_{PHL} - t_{PLH} $		0	4.9	ns		
$t_{sk(o)}$	Channel-to-channel output skew time <sup>(2)</sup>	Same-direction channels			4	ns	
$t_{sk(pp)}$	Part-to-part skew time <sup>(3)</sup>				4.4	ns	
$t_r$	Output signal rise time	See Figure 15		2.4	3.9	ns	
$t_f$	Output signal fall time			2.4	3.9	ns	
$t_{PHZ}$	Disable propagation delay, high-to-high impedance output	See Figure 16		9	20	ns	
$t_{PLZ}$	Disable propagation delay, low-to-high impedance output			9	20	ns	
$t_{PZH}$	Enable propagation delay, high impedance-to-high output for ISO774x				7	20	ns
	Enable propagation delay, high impedance-to-high output for ISO774x with F suffix				3	8.5	$\mu\text{s}$
$t_{PZL}$	Enable propagation delay, high impedance-to-low output for ISO774x				3	8.5	$\mu\text{s}$
	Enable propagation delay, high impedance-to-low output for ISO774x with F suffix				7	20	ns
$t_{DO}$	Default output delay time from input power loss	Measured from the time $V_{CC}$ goes below 1.7 V. See		0.1	0.3	$\mu\text{s}$	
$t_{ie}$	Time interval error	$2^{16} - 1$ PRBS data at 100 Mbps		0.8		ns	

- (1) Also known as pulse skew.
- (2)  $t_{sk(o)}$  is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.
- (3)  $t_{sk(pp)}$  is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

## 6.16 Switching Characteristics—3.3-V Supply

 $V_{CC1} = V_{CC2} = 3.3\text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
$t_{PLH}$ , $t_{PHL}$	Propagation delay time	See Figure 15	6	11	16	ns	
PWD	Pulse width distortion <sup>(1)</sup> $ t_{PHL} - t_{PLH} $		0.1	5	ns		
$t_{sk(o)}$	Channel-to-channel output skew time <sup>(2)</sup>	Same-direction channels			4.1	ns	
$t_{sk(pp)}$	Part-to-part skew time <sup>(3)</sup>				4.5	ns	
$t_r$	Output signal rise time	See Figure 15		1.3	3	ns	
$t_f$	Output signal fall time			1.3	3	ns	
$t_{PHZ}$	Disable propagation delay, high-to-high impedance output	See Figure 16		17	30	ns	
$t_{PLZ}$	Disable propagation delay, low-to-high impedance output			17	30	ns	
$t_{PZH}$	Enable propagation delay, high impedance-to-high output for ISO774x				17	30	ns
	Enable propagation delay, high impedance-to-high output for ISO774x with F suffix				3.2	8.5	$\mu\text{s}$
$t_{PZL}$	Enable propagation delay, high impedance-to-low output for ISO774x				3.2	8.5	$\mu\text{s}$
	Enable propagation delay, high impedance-to-low output for ISO774x with F suffix				17	30	ns
$t_{DO}$	Default output delay time from input power loss	Measured from the time $V_{CC}$ goes below 1.7 V. See		0.1	0.3	$\mu\text{s}$	
$t_{ie}$	Time interval error	$2^{16} - 1$ PRBS data at 100 Mbps		0.9		ns	

- (1) Also known as pulse skew.
- (2)  $t_{sk(o)}$  is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.
- (3)  $t_{sk(pp)}$  is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.



## 6.17 Switching Characteristics—2.5-V Supply

 $V_{CC1} = V_{CC2} = 2.5\text{ V} \pm 10\%$  (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
$t_{PLH}, t_{PHL}$	Propagation delay time	See <a href="#">Figure 15</a>	7.5	12	18.5	ns	
PWD	Pulse width distortion <sup>(1)</sup> $ t_{PHL} - t_{PLH} $		0.2	5.1		ns	
$t_{sk(o)}$	Channel-to-channel output skew time <sup>(2)</sup>	Same-direction Channels			4.1	ns	
$t_{sk(pp)}$	Part-to-part skew time <sup>(3)</sup>				4.6	ns	
$t_r$	Output signal rise time	See <a href="#">Figure 15</a>		1	3.5	ns	
$t_f$	Output signal fall time			1	3.5	ns	
$t_{PHZ}$	Disable propagation delay, high-to-high impedance output	See <a href="#">Figure 16</a>		22	40	ns	
$t_{PLZ}$	Disable propagation delay, low-to-high impedance output			22	40	ns	
$t_{pZH}$	Enable propagation delay, high impedance-to-high output for ISO774x				18	40	ns
	Enable propagation delay, high impedance-to-high output for ISO774x with F suffix				3.3	8.5	$\mu\text{s}$
$t_{pZL}$	Enable propagation delay, high impedance-to-low output for ISO774x				3.3	8.5	$\mu\text{s}$
	Enable propagation delay, high impedance-to-low output for ISO774x with F suffix				18	40	ns
$t_{DO}$	Default output delay time from input power loss	Measured from the time $V_{CC}$ goes below 1.7 V. See		0.1	0.3	$\mu\text{s}$	
$t_{ie}$	Time interval error	$2^{16} - 1$ PRBS data at 100 Mbps		0.7		ns	

- (1) Also known as pulse skew.
- (2)  $t_{sk(o)}$  is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.
- (3)  $t_{sk(pp)}$  is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

### 6.18 Insulation Characteristics Curves

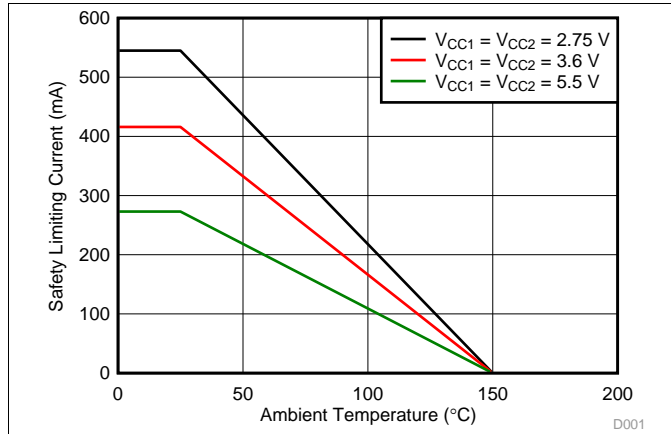


Figure 1. Thermal Derating Curve for Safety Limiting Current for DW-16 Package

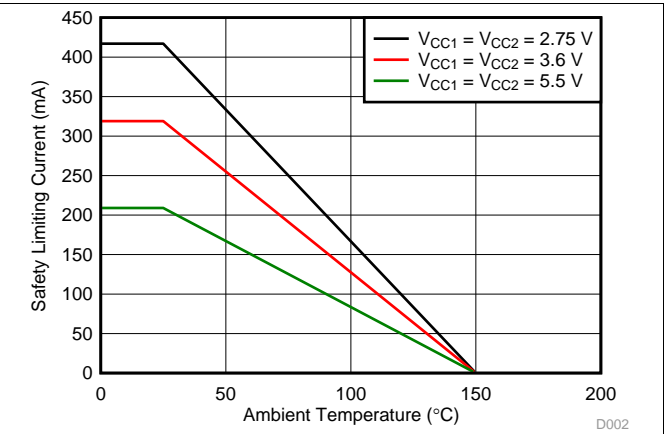


Figure 2. Thermal Derating Curve for Safety Limiting Current for DBQ-16 Package

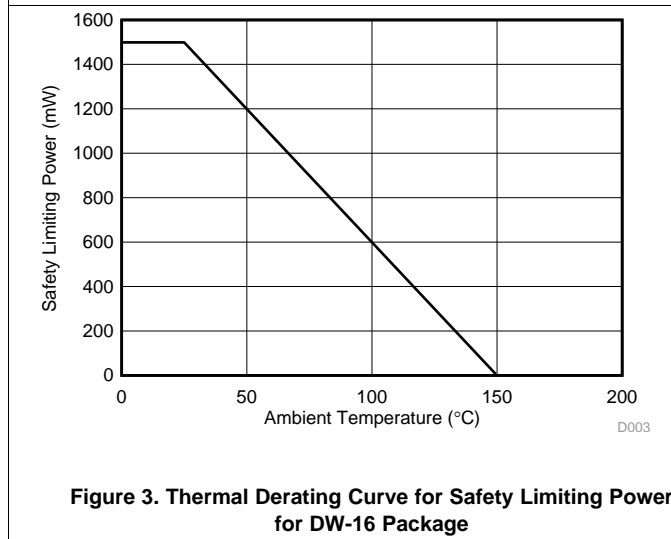


Figure 3. Thermal Derating Curve for Safety Limiting Power for DW-16 Package

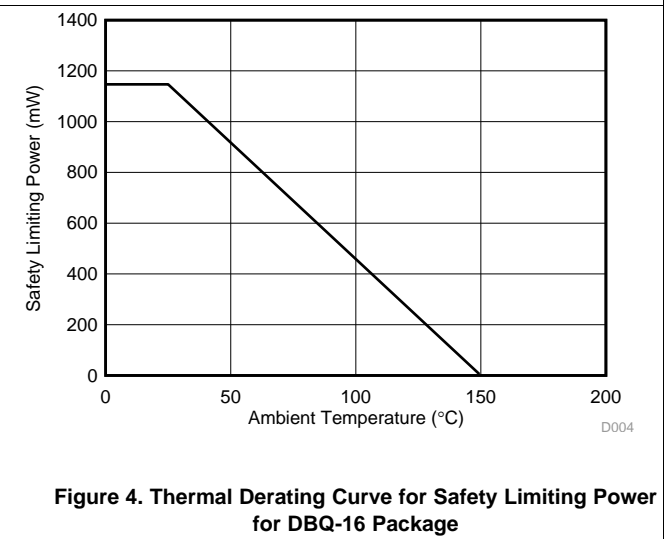
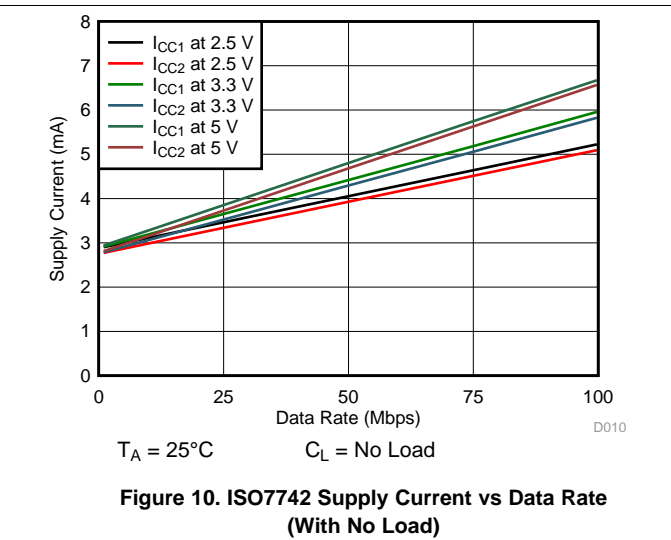
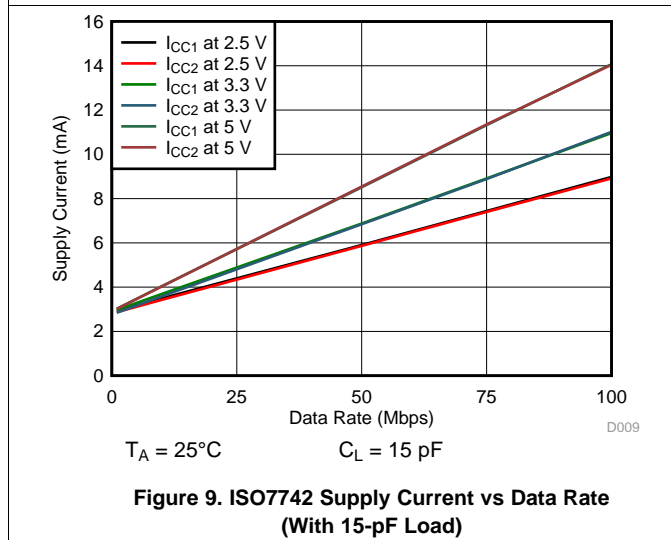
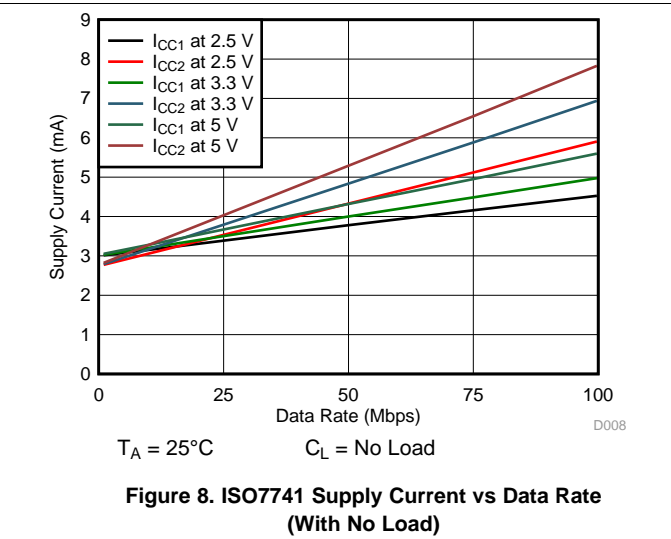
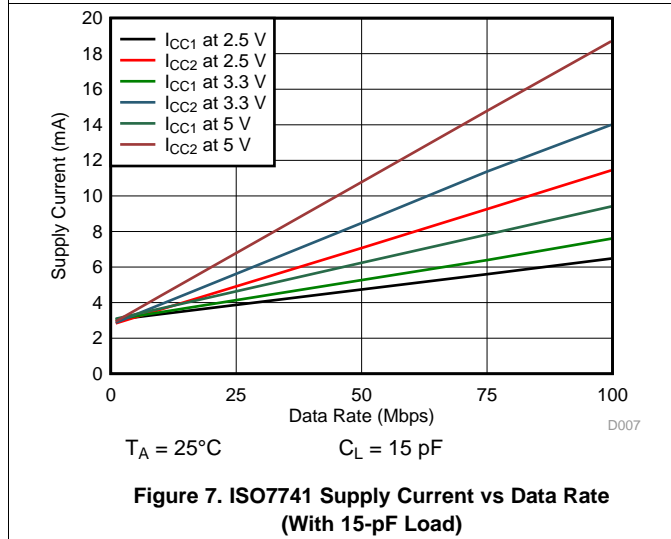
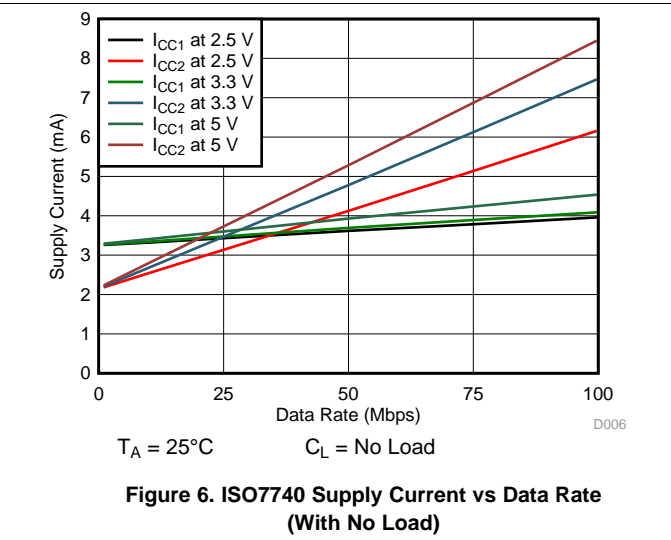
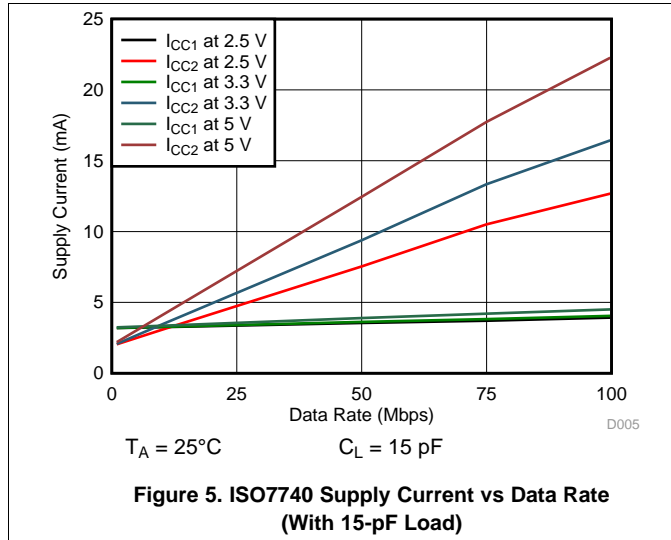


Figure 4. Thermal Derating Curve for Safety Limiting Power for DBQ-16 Package

### 6.19 Typical Characteristics



Typical Characteristics (continued)

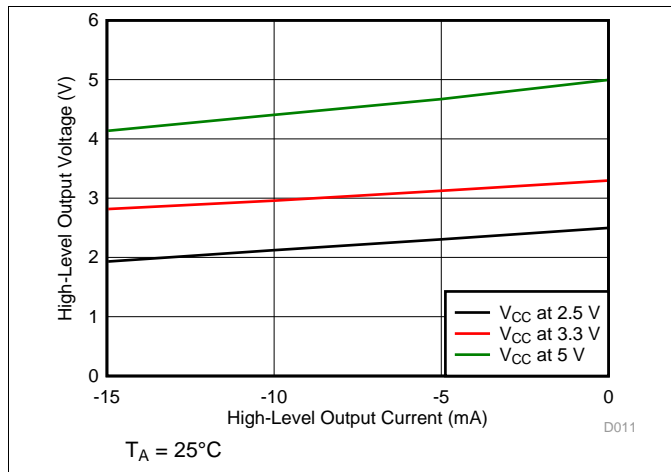


Figure 11. High-Level Output Voltage vs High-level Output Current

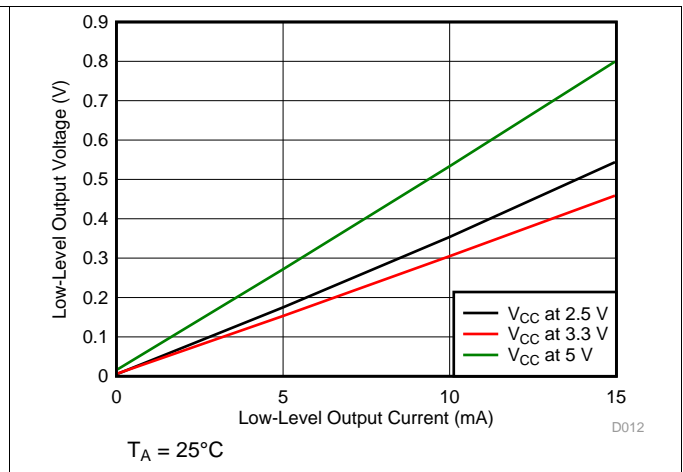


Figure 12. Low-Level Output Voltage vs Low-Level Output Current

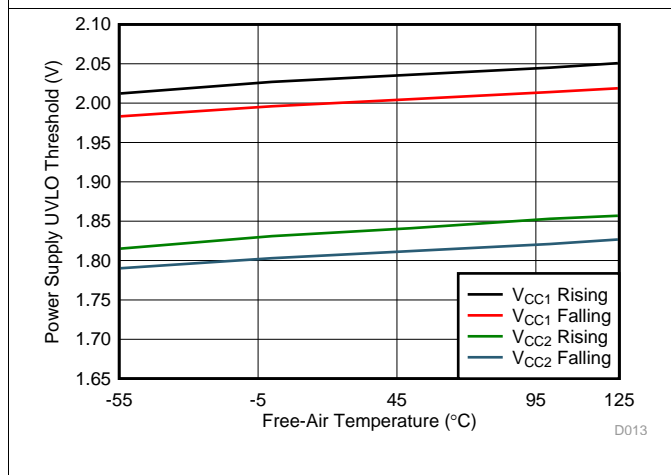


Figure 13. Power Supply Undervoltage Threshold vs Free-Air Temperature

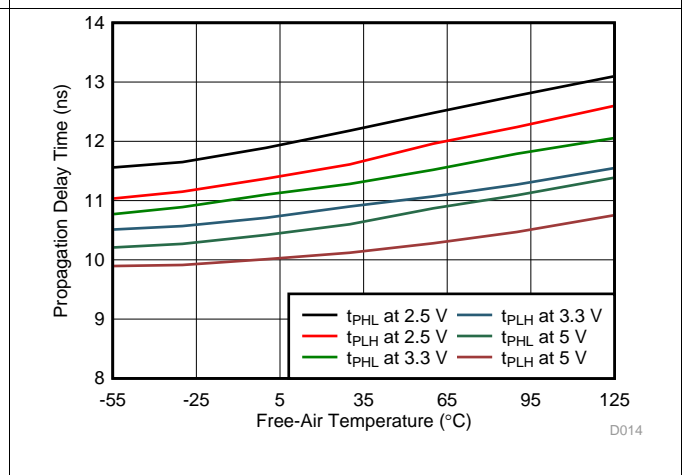
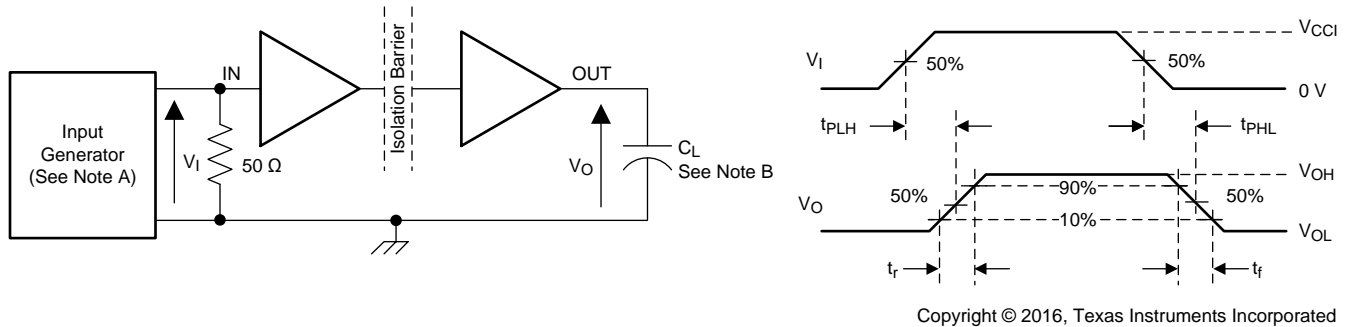


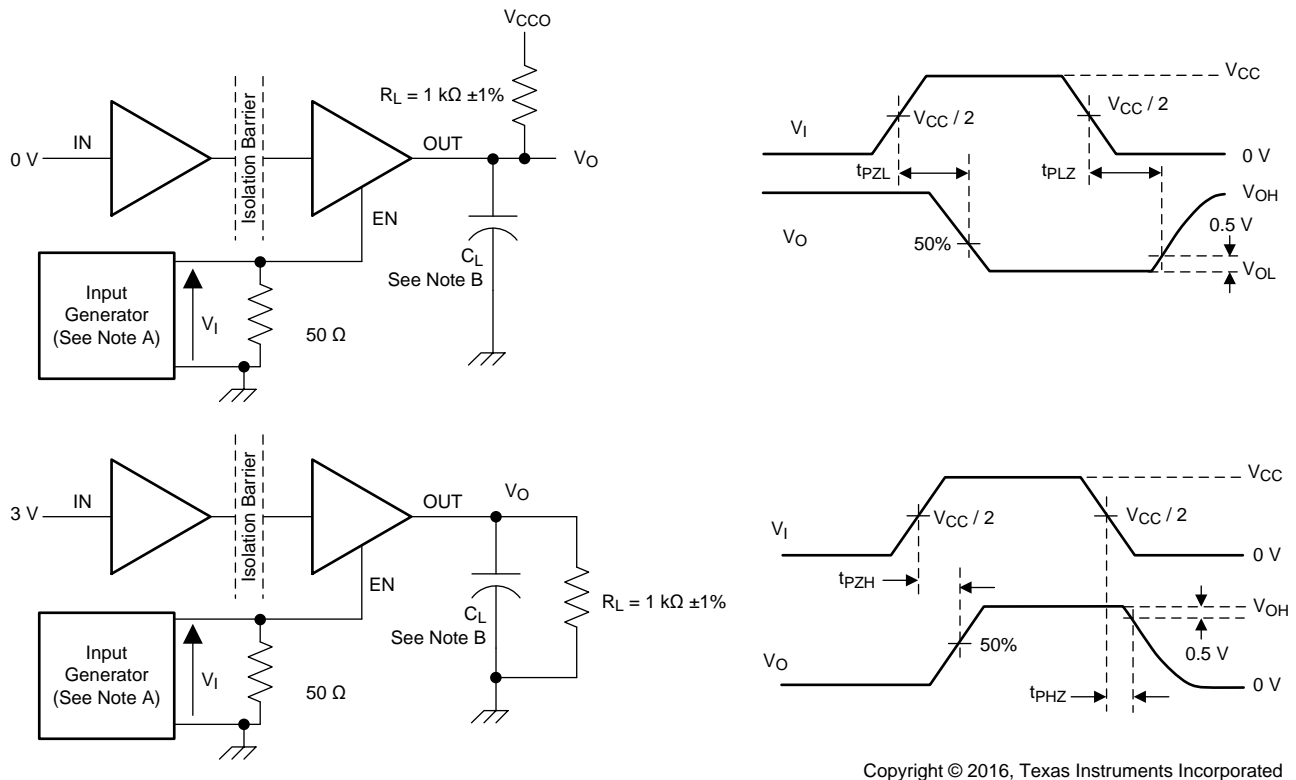
Figure 14. Propagation Delay Time vs Free-Air Temperature

## 7 Parameter Measurement Information



- The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50 kHz, 50% duty cycle,  $t_r \leq 3$  ns,  $t_f \leq 3$  ns,  $Z_O = 50 \Omega$ . At the input,  $50 \Omega$  resistor is required to terminate Input Generator signal. It is not needed in actual application.
- $C_L = 15$  pF and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

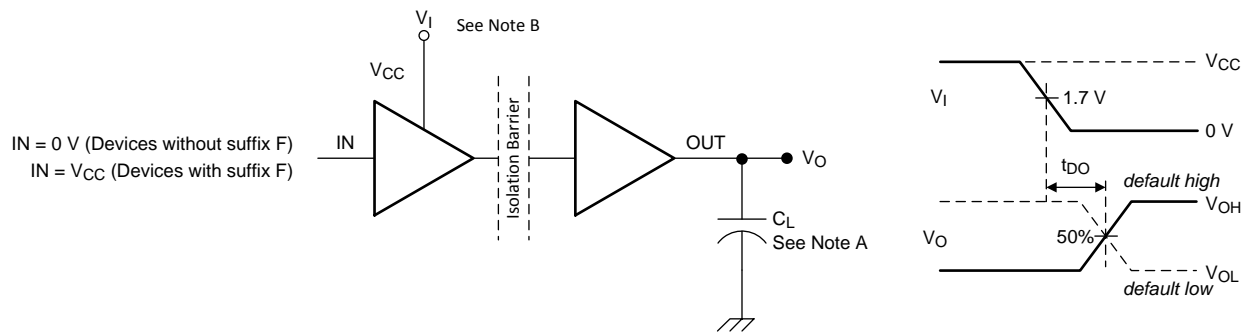
Figure 15. Switching Characteristics Test Circuit and Voltage Waveforms



- The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  10 kHz, 50% duty cycle,  $t_r \leq 3$  ns,  $t_f \leq 3$  ns,  $Z_O = 50 \Omega$ .
- $C_L = 15$  pF and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

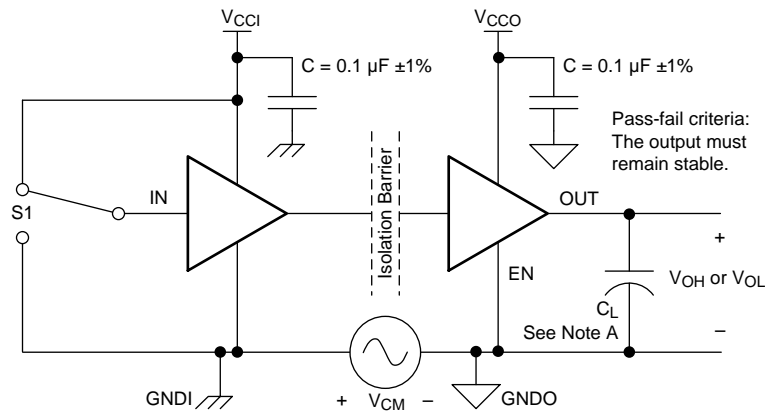
Figure 16. Enable/Disable Propagation Delay Time Test Circuit and Waveform

**Parameter Measurement Information (continued)**



- A.  $C_L = 15 \text{ pF}$  and includes instrumentation and fixture capacitance within  $\pm 20\%$ .
- B. Power Supply Ramp Rate =  $10 \text{ mV/ns}$

**Figure 17. Default Output Delay Time Test Circuit and Voltage Waveforms**



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- A.  $C_L = 15 \text{ pF}$  and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

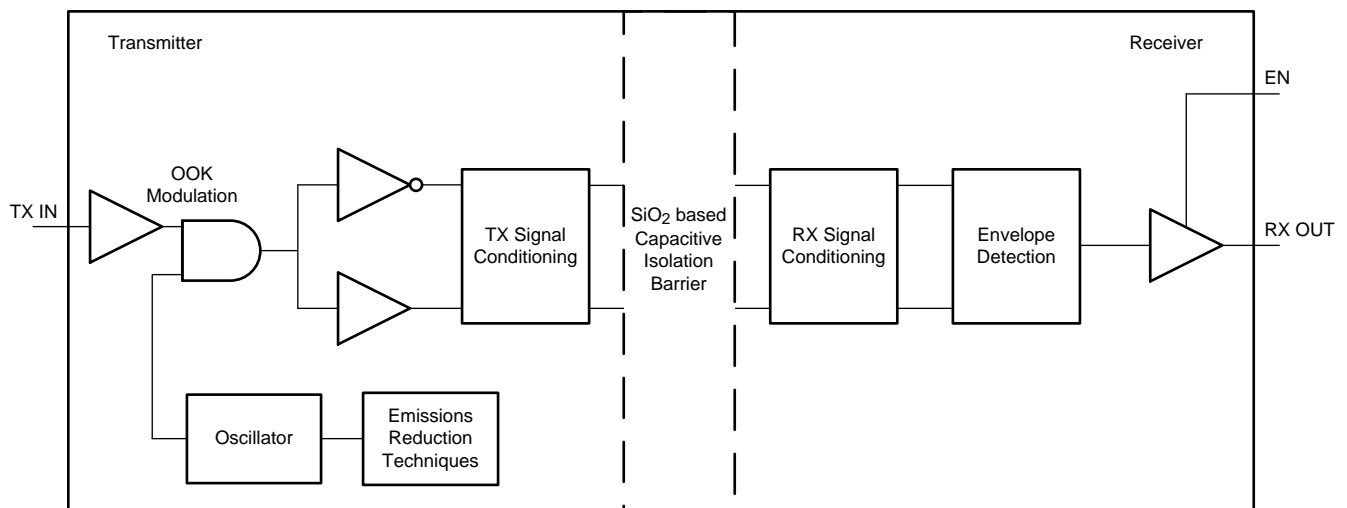
**Figure 18. Common-Mode Transient Immunity Test Circuit**

## 8 Detailed Description

### 8.1 Overview

The ISO774x family of devices have an ON-OFF keying (OOK) modulation scheme to transmit the digital data across a silicon dioxide based isolation barrier. The transmitter sends a high frequency carrier across the barrier to represent one digital state and sends no signal to represent the other digital state. The receiver demodulates the signal after advanced signal conditioning and produces the output through a buffer stage. If the ENx pin is low then the output goes to high impedance. The ISO774x devices also incorporate advanced circuit techniques to maximize the CMTI performance and minimize the radiated emissions due the high frequency carrier and IO buffer switching. The conceptual block diagram of a digital capacitive isolator, [Figure 19](#), shows a functional block diagram of a typical channel.

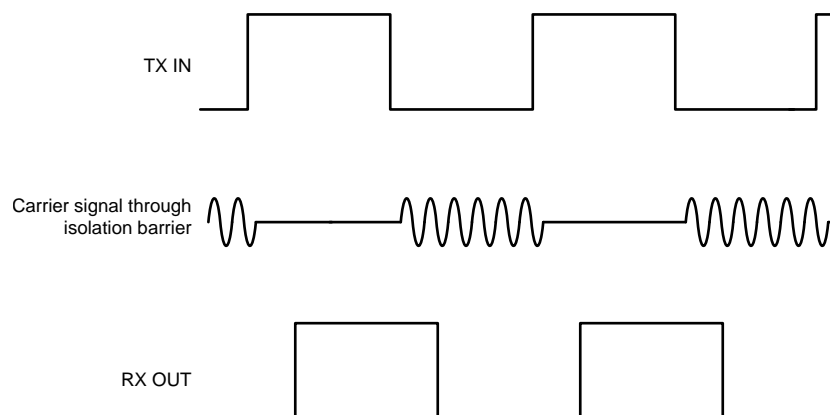
### 8.2 Functional Block Diagram



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**Figure 19. Conceptual Block Diagram of a Digital Capacitive Isolator**

[Figure 20](#) shows a conceptual detail of how the ON-OFF keying scheme works.



**Figure 20. On-Off Keying (OOK) Based Modulation Scheme**

### 8.3 Feature Description

Table 1 provides an overview of the device features.

**Table 1. Device Features**

PART NUMBER	CHANNEL DIRECTION	MAXIMUM DATA RATE	DEFAULT OUTPUT	PACKAGE	RATED ISOLATION <sup>(1)</sup>
ISO7740	4 Forward, 0 Reverse	100 Mbps	High	DW-16	5000 V <sub>RMS</sub> / 8000 V <sub>PK</sub>
				DBQ-16	2500 V <sub>RMS</sub> / 3600 V <sub>PK</sub>
ISO7740 with F suffix	4 Forward, 0 Reverse	100 Mbps	Low	DW-16	5000 V <sub>RMS</sub> / 8000 V <sub>PK</sub>
				DBQ-16	2500 V <sub>RMS</sub> / 3600 V <sub>PK</sub>
ISO7741	3 Forward, 1 Reverse	100 Mbps	High	DW-16	5000 V <sub>RMS</sub> / 8000 V <sub>PK</sub>
				DBQ-16	2500 V <sub>RMS</sub> / 3600 V <sub>PK</sub>
ISO7741 with F suffix	3 Forward, 1 Reverse	100 Mbps	Low	DW-16	5000 V <sub>RMS</sub> / 8000 V <sub>PK</sub>
				DBQ-16	2500 V <sub>RMS</sub> / 3600 V <sub>PK</sub>
ISO7742	2 Forward, 2 Reverse	100 Mbps	High	DW-16	5000 V <sub>RMS</sub> / 8000 V <sub>PK</sub>
				DBQ-16	2500 V <sub>RMS</sub> / 3600 V <sub>PK</sub>
ISO7742 with F suffix	2 Forward, 2 Reverse	100 Mbps	Low	DW-16	5000 V <sub>RMS</sub> / 8000 V <sub>PK</sub>
				DBQ-16	2500 V <sub>RMS</sub> / 3600 V <sub>PK</sub>

(1) See [Safety-Related Certifications](#) for detailed isolation ratings.

#### 8.3.1 Electromagnetic Compatibility (EMC) Considerations

Many applications in harsh industrial environment are sensitive to disturbances such as electrostatic discharge (ESD), electrical fast transient (EFT), surge and electromagnetic emissions. These electromagnetic disturbances are regulated by international standards such as IEC 61000-4-x and CISPR 22. Although system-level performance and reliability depends, to a large extent, on the application board design and layout, the ISO774x family of devices incorporates many chip-level design improvements for overall system robustness. Some of these improvements include:

- Robust ESD protection cells for input and output signal pins and inter-chip bond pads.
- Low-resistance connectivity of ESD cells to supply and ground pins.
- Enhanced performance of high voltage isolation capacitor for better tolerance of ESD, EFT and surge events.
- Bigger on-chip decoupling capacitors to bypass undesirable high energy signals through a low impedance path.
- PMOS and NMOS devices isolated from each other by using guard rings to avoid triggering of parasitic SCRs.
- Reduced common mode currents across the isolation barrier by ensuring purely differential internal operation.



### 8.4 Device Functional Modes

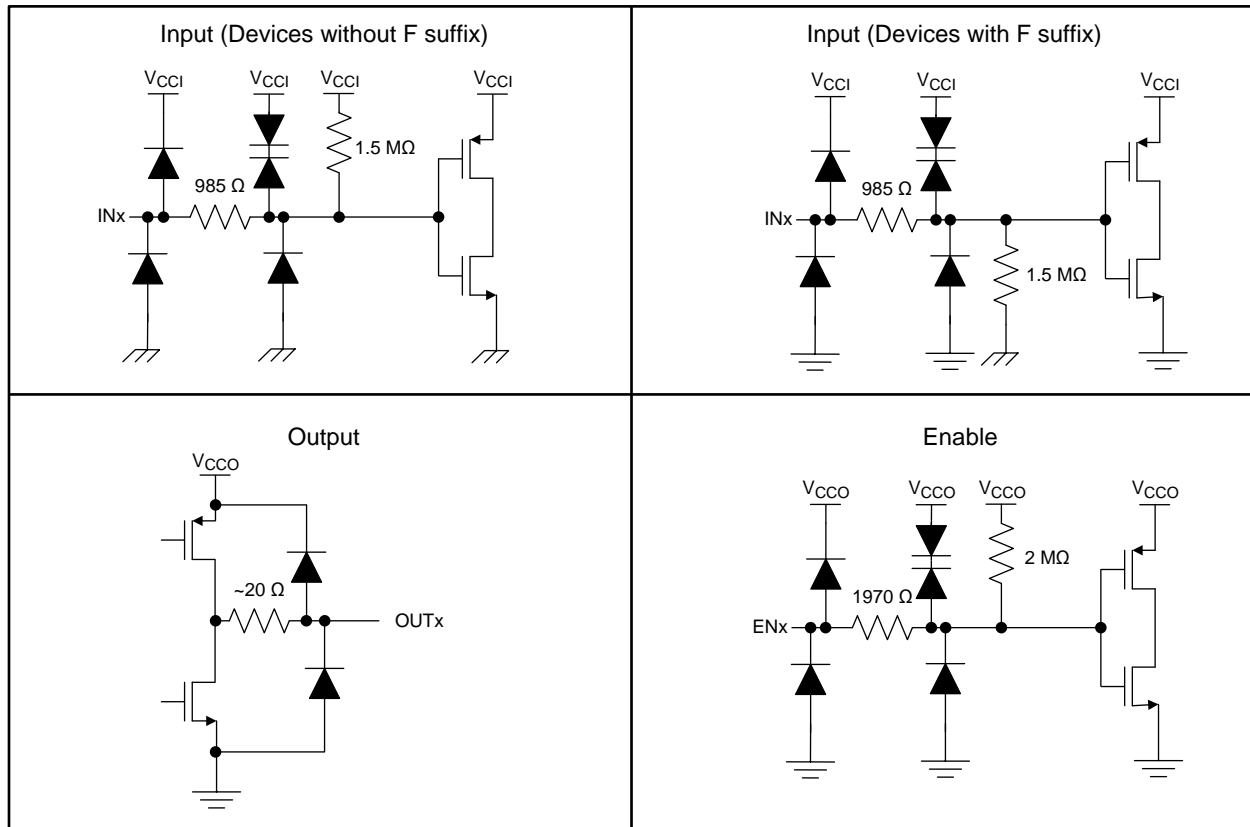
Table 2 lists the functional modes for the ISO774x devices.

Table 2. Function Table<sup>(1)</sup>

V <sub>CCI</sub>	V <sub>CCO</sub>	INPUT (IN <sub>x</sub> ) <sup>(2)</sup>	OUTPUT ENABLE (EN <sub>x</sub> )	OUTPUT (OUT <sub>x</sub> )	COMMENTS
PU	PU	H	H or open	H	Normal Operation: A channel output assumes the logic state of its input.
		L	H or open	L	
		Open	H or open	Default	Default mode: When IN <sub>x</sub> is open, the corresponding channel output goes to its default logic state. Default is <i>High</i> for ISO774x and <i>Low</i> for ISO774x with F suffix.
X	PU	X	L	Z	A low value of output enable causes the outputs to be high-impedance.
PD	PU	X	H or open	Default	Default mode: When V <sub>CCI</sub> is unpowered, a channel output assumes the logic state based on the selected default option. Default is <i>High</i> for ISO774x and <i>Low</i> for ISO774x with F suffix. When V <sub>CCI</sub> transitions from unpowered to powered-up, a channel output assumes the logic state of the input. When V <sub>CCI</sub> transitions from powered-up to unpowered, channel output assumes the selected default state.
X	PD	X	X	Undetermined	When V <sub>CCO</sub> is unpowered, a channel output is undetermined <sup>(3)</sup> . When V <sub>CCO</sub> transitions from unpowered to powered-up, a channel output assumes the logic state of the input.

- (1) V<sub>CCI</sub> = Input-side V<sub>CC</sub>; V<sub>CCO</sub> = Output-side V<sub>CC</sub>; PU = Powered up (V<sub>CC</sub> ≥ 2.25 V); PD = Powered down (V<sub>CC</sub> ≤ 1.7 V); X = Irrelevant; H = High level; L = Low level; Z = High Impedance
- (2) A strongly driven input signal can weakly power the floating V<sub>CC</sub> through an internal protection diode and cause undetermined output.
- (3) The outputs are in undetermined state when 1.7 V < V<sub>CCI</sub>, V<sub>CCO</sub> < 2.25 V.

#### 8.4.1 Device I/O Schematics



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Figure 21. Device I/O Schematics

## 9 Application and Implementation

### NOTE

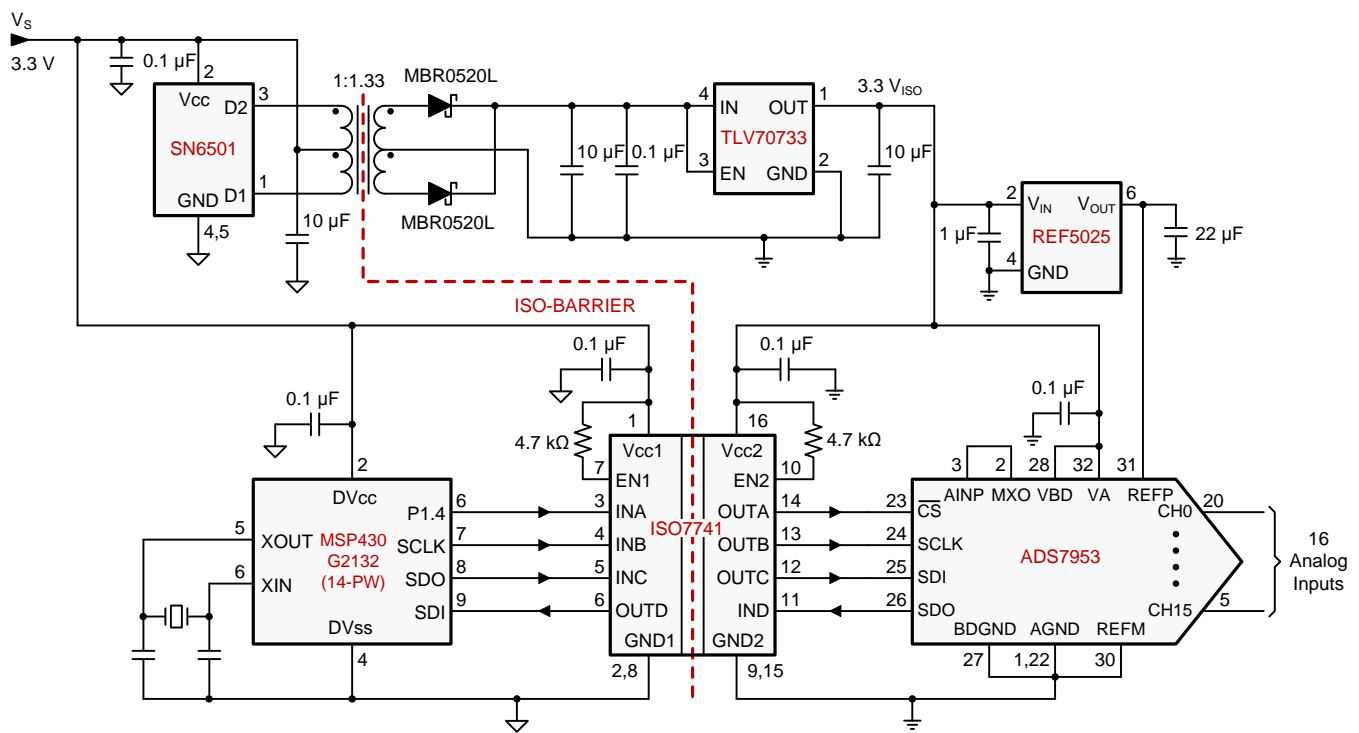
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The ISO774x devices are high-performance, quad-channel digital isolators. These devices come with enable pins on each side which can be used to put the respective outputs in high impedance for multi master driving applications and reduce power consumption. The ISO774x devices use single-ended CMOS-logic switching technology. The voltage range is from 2.25 V to 5.5 V for both supplies,  $V_{CC1}$  and  $V_{CC2}$ . When designing with digital isolators, keep in mind that because of the single-ended design structure, digital isolators do not conform to any specific interface standard and are only intended for isolating single-ended CMOS or TTL digital signal lines. The isolator is typically placed between the data controller (that is,  $\mu C$  or UART), and a data converter or a line transceiver, regardless of the interface type or standard.

### 9.2 Typical Application

Figure 22 shows the isolated serial peripheral interface (SPI).



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Figure 22. Isolated SPI for an Analog Input Module With 16 Input

## Typical Application (continued)

### 9.2.1 Design Requirements

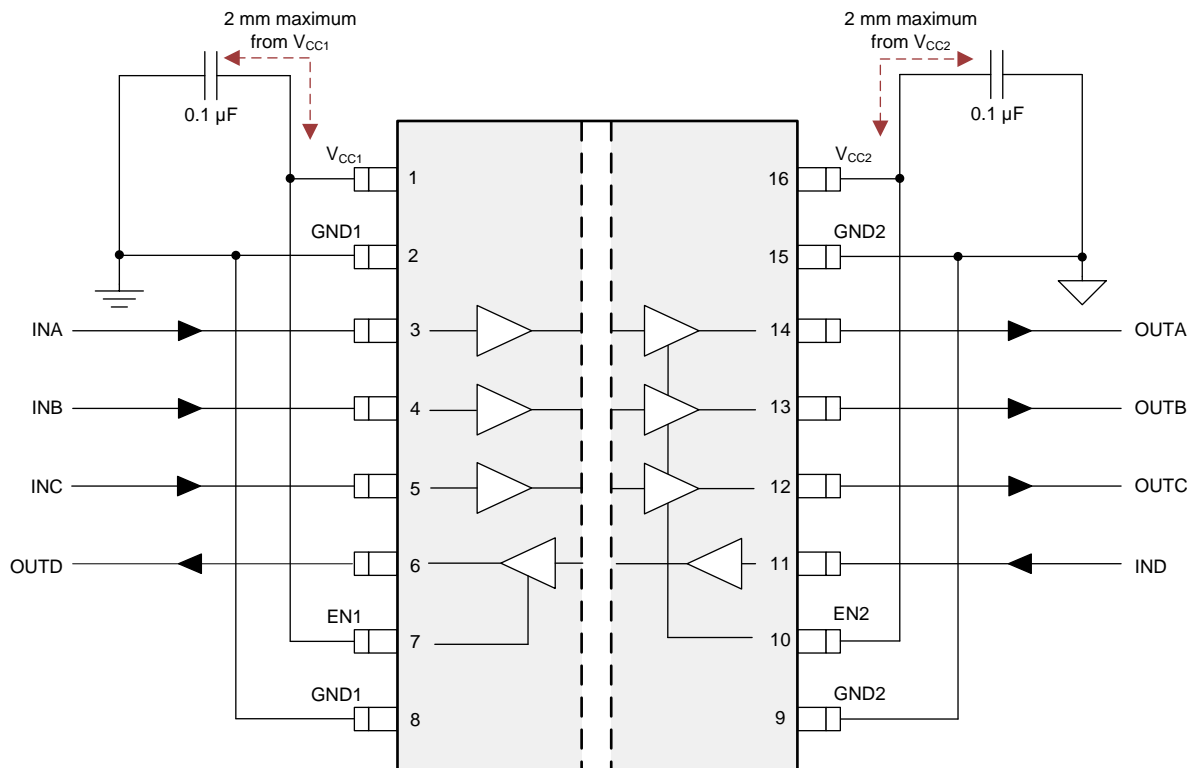
To design with these devices, use the parameters listed in [Table 3](#).

**Table 3. Design Parameters**

PARAMETER	VALUE
Supply voltage, $V_{CC1}$ and $V_{CC2}$	2.25 to 5.5 V
Decoupling capacitor between $V_{CC1}$ and GND1	0.1 $\mu$ F
Decoupling capacitor from $V_{CC2}$ and GND2	0.1 $\mu$ F

### 9.2.2 Detailed Design Procedure

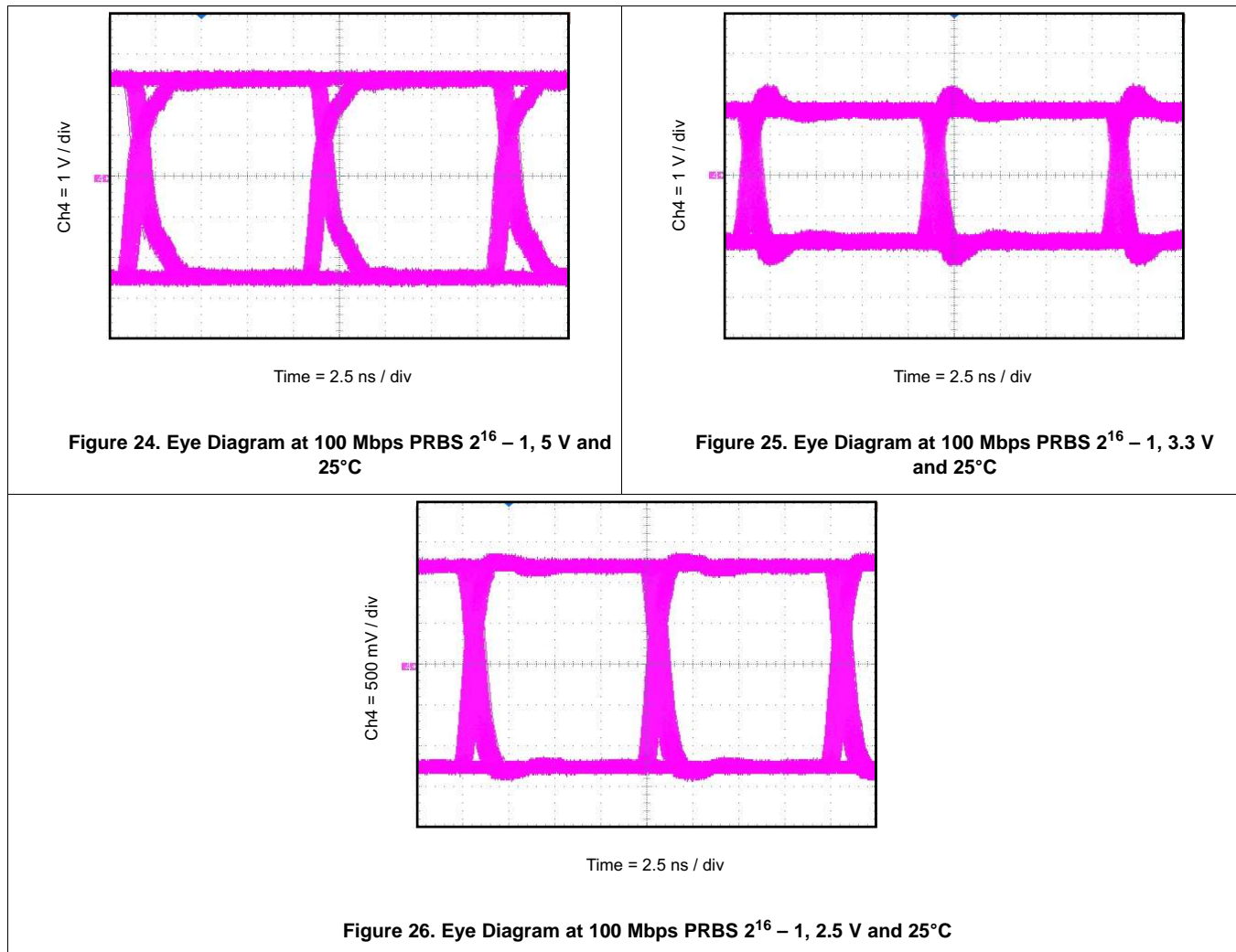
Unlike optocouplers, which require external components to improve performance, provide bias, or limit current, the ISO774x family of devices only require two external bypass capacitors to operate.



**Figure 23. Typical ISO7741 Circuit Hook-up**

### 9.2.3 Application Curve

The following typical eye diagrams of the ISO774x family of devices indicates low jitter and wide open eye at the maximum data rate of 100 Mbps.



## 10 Power Supply Recommendations

To help ensure reliable operation at data rates and supply voltages, a 0.1- $\mu$ F bypass capacitor is recommended at the input and output supply pins ( $V_{CC1}$  and  $V_{CC2}$ ). The capacitors should be placed as close to the supply pins as possible. If only a single primary-side power supply is available in an application, isolated power can be generated for the secondary-side with the help of a transformer driver such as Texas Instruments' [SN6501](#) or [SN6505A](#). For such applications, detailed power supply design and transformer selection recommendations are available in [SN6501 Transformer Driver for Isolated Power Supplies](#) (SLLSEA0) or [SN6505A Low-Noise 1-A Transformer Drivers for Isolated Power Supplies](#) (SLLSEP9).

## 11 Layout

### 11.1 Layout Guidelines

A minimum of four layers is required to accomplish a low EMI PCB design (see [Figure 27](#)). Layer stacking should be in the following order (top-to-bottom): high-speed signal layer, ground plane, power plane and low-frequency signal layer.

- Routing the high-speed traces on the top layer avoids the use of vias (and the introduction of their inductances) and allows for clean interconnects between the isolator and the transmitter and receiver circuits of the data link.
- Placing a solid ground plane next to the high-speed signal layer establishes controlled impedance for transmission line interconnects and provides an excellent low-inductance path for the return current flow.
- Placing the power plane next to the ground plane creates additional high-frequency bypass capacitance of approximately 100 pF/inch<sup>2</sup>.
- Routing the slower speed control signals on the bottom layer allows for greater flexibility as these signal links usually have margin to tolerate discontinuities such as vias.

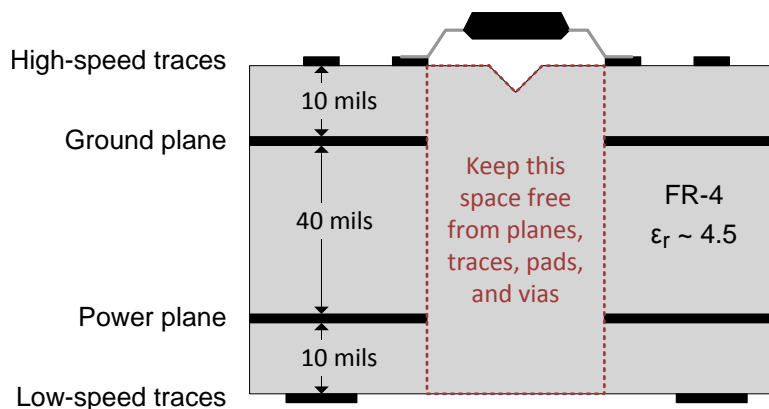
If an additional supply voltage plane or signal layer is needed, add a second power or ground plane system to the stack to keep it symmetrical. This makes the stack mechanically stable and prevents it from warping. Also the power and ground plane of each power system can be placed closer together, thus increasing the high-frequency bypass capacitance significantly.

For detailed layout recommendations, refer to the [Digital Isolator Design Guide](#) (SLLA284).

#### 11.1.1 PCB Material

For digital circuit boards operating below 150 Mbps, (or rise and fall times higher than 1 ns), and trace lengths of up to 10 inches, use standard FR-4 UL94V-0 printed circuit boards. This PCB is preferred over cheaper alternatives due to its lower dielectric losses at high frequencies, less moisture absorption, greater strength and stiffness, and self-extinguishing flammability-characteristics.

### 11.2 Layout Example



**Figure 27. Layout Example Schematic**

## 12 Device and Documentation Support

### 12.1 Documentation Support

#### 12.1.1 Related Documentation

For related documentation, see the following:

- [ADS79xx 12/10/8-Bit, 1 MSPS, 16/12/8/4-Channel, Single-Ended, MicroPower, Serial Interface ADCs \(SLAS605\)](#)
- [Digital Isolator Design Guide \(SLLA284\)](#)
- [Isolation Glossary \(SLLA353\)](#)
- [MSP430G2132 Mixed Signal Microcontroller \(SLAS723\)](#)
- [REF50xx Low-Noise, Very Low Drift, Precision Voltage Reference \(SBOS410\)](#)
- [SN6501 Transformer Driver for Isolated Power Supplies \(SLLSEA0\)](#)
- [SN6505A Low-Noise 1-A Transformer Drivers for Isolated Power Supplies \(SLLSEP9\)](#)
- [TLV707, TLV707P 200-mA, Low-IQ, Low-Noise, Low-Dropout Regulator for Portable Devices \(SBVS153\)](#)

#### 12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

**Table 4. Related Links**

PARTS	PRODUCT FOLDER	ORDER NOW	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
ISO7740	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>
ISO7741	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>
ISO7742	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>

#### 12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 12.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 12.5 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### 12.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

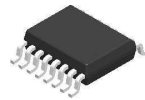
## 12.7 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

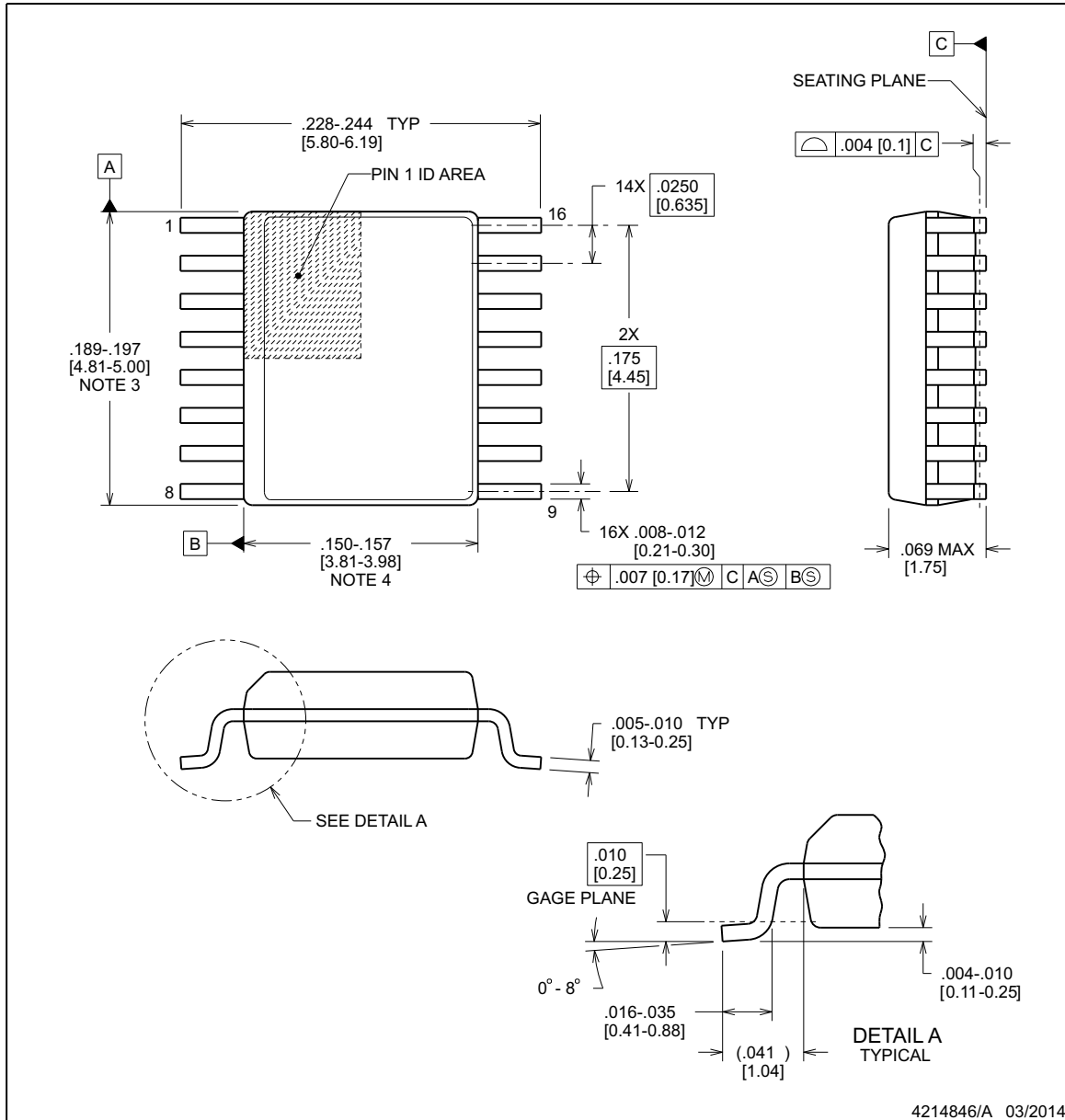


**DBQ0016A**

**PACKAGE OUTLINE**

**SSOP - 1.75 mm max height**

SHRINK SMALL-OUTLINE PACKAGE



NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MO-137, variation AB.

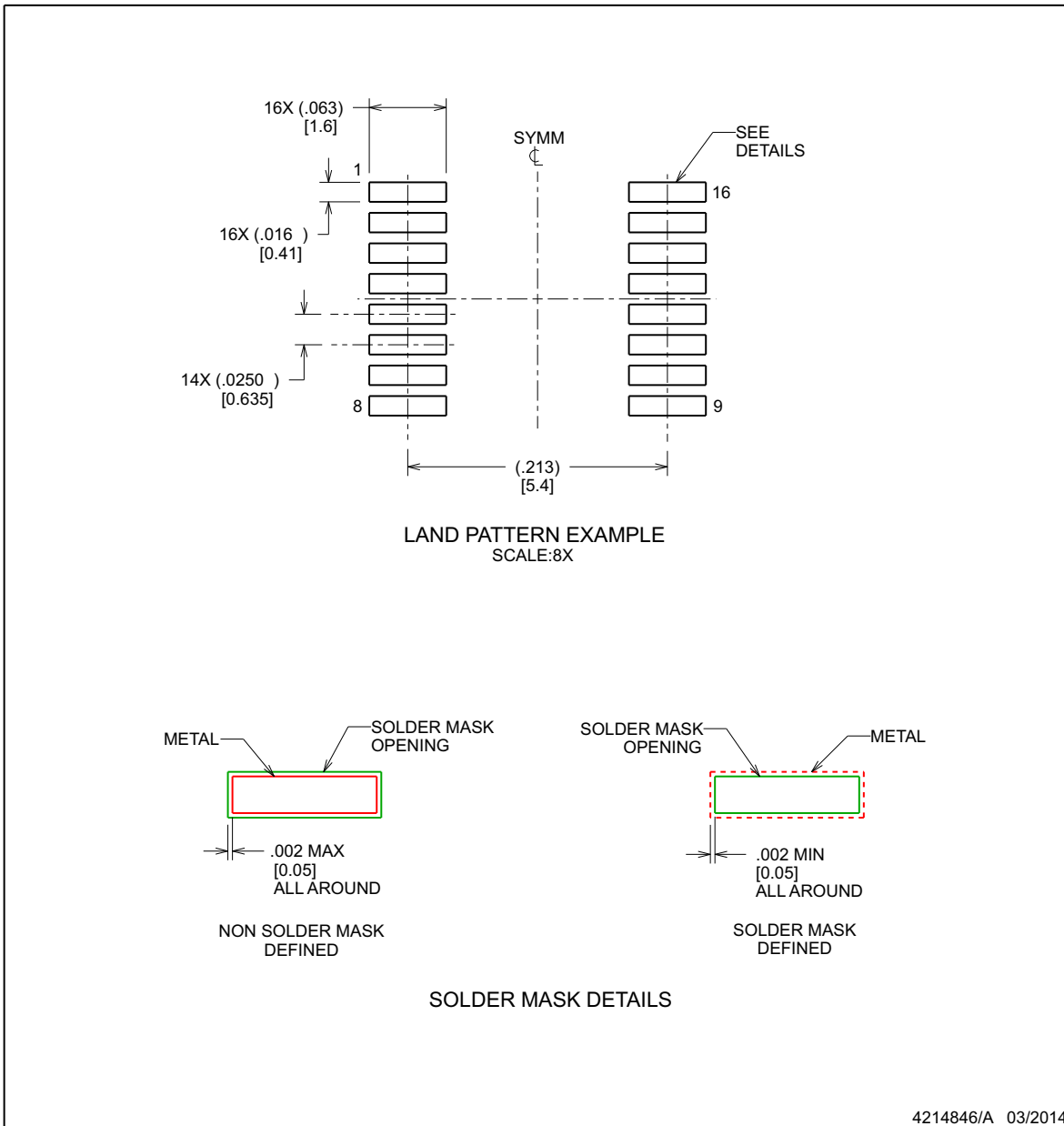


## EXAMPLE BOARD LAYOUT

**DBQ0016A**

**SSOP - 1.75 mm max height**

SHRINK SMALL-OUTLINE PACKAGE



NOTES: (continued)

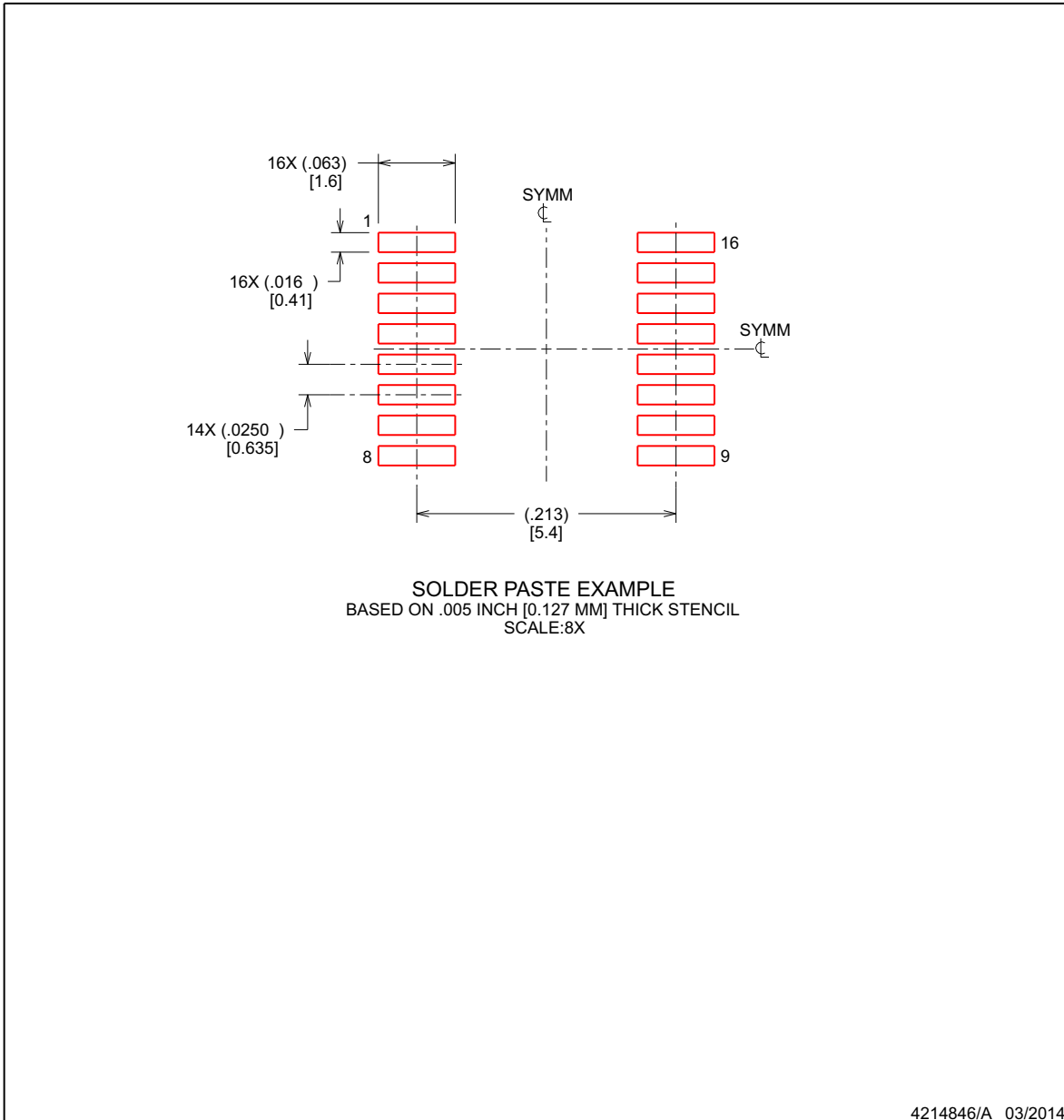
- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

**EXAMPLE STENCIL DESIGN**

**DBQ0016A**

**SSOP - 1.75 mm max height**

SHRINK SMALL-OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.

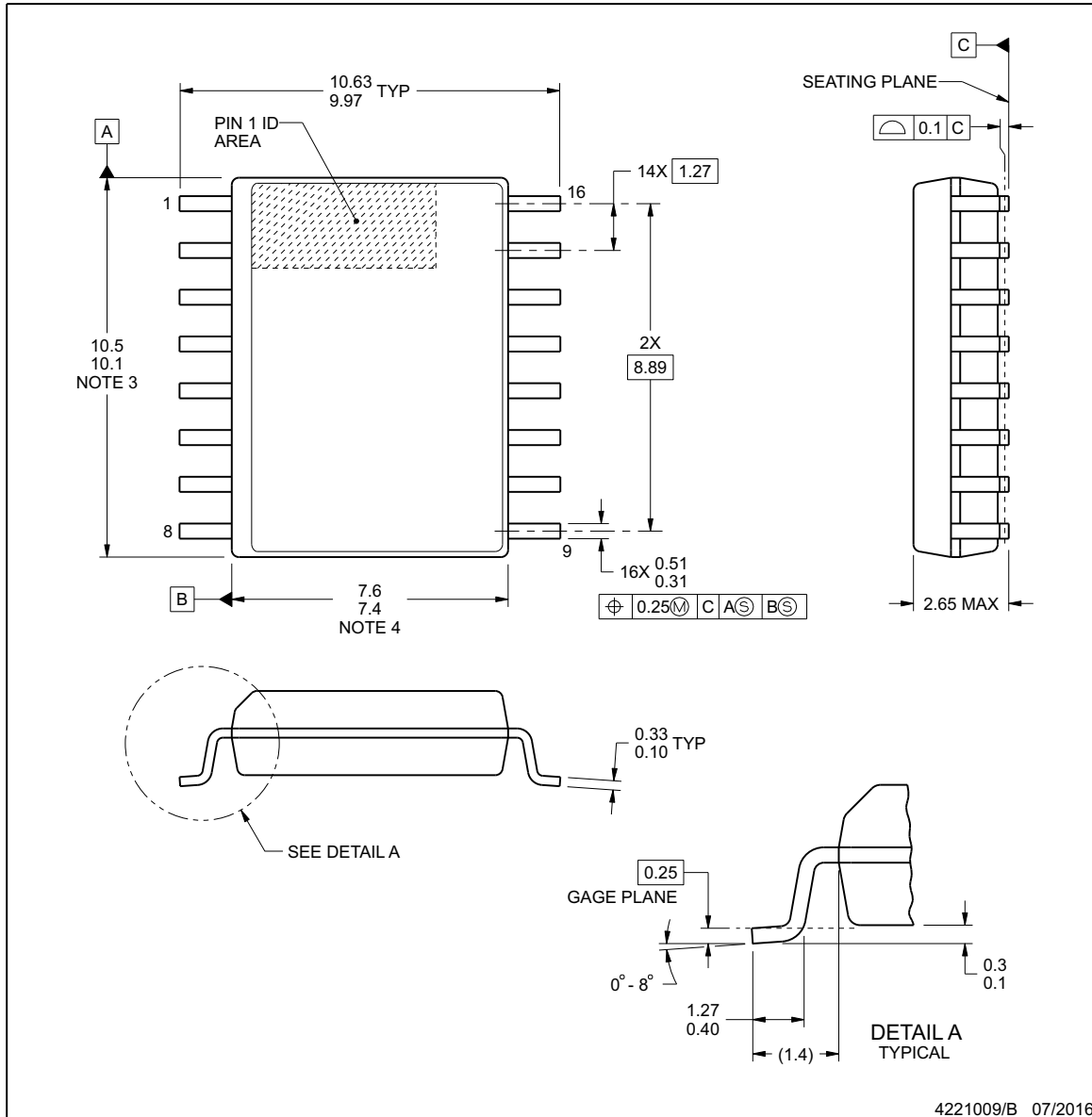


**DW0016B**

**PACKAGE OUTLINE**

**SOIC - 2.65 mm max height**

SOIC



4221009/B 07/2016

**NOTES:**

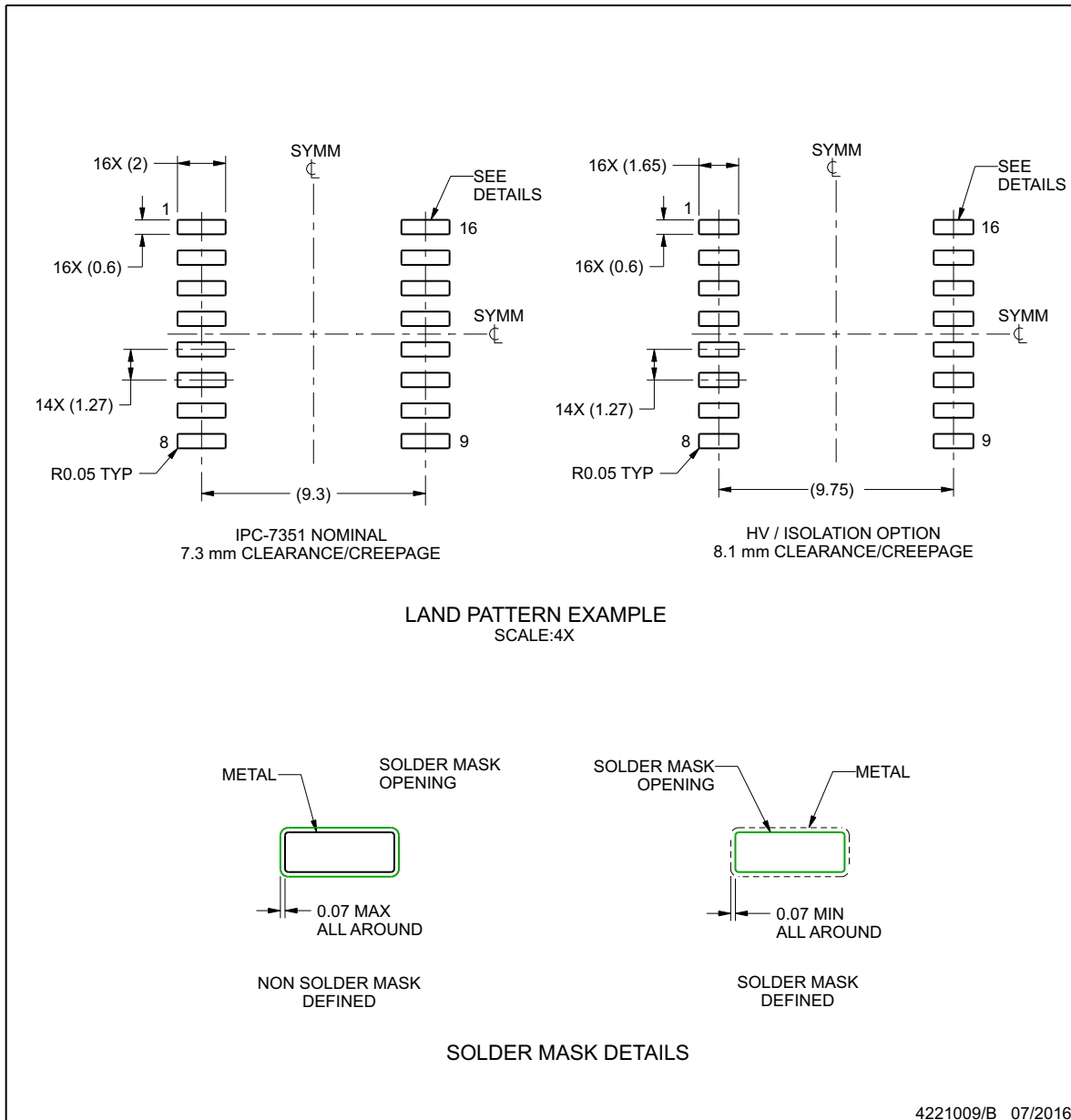
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
5. Reference JEDEC registration MS-013.

**EXAMPLE BOARD LAYOUT**

**DW0016B**

**SOIC - 2.65 mm max height**

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

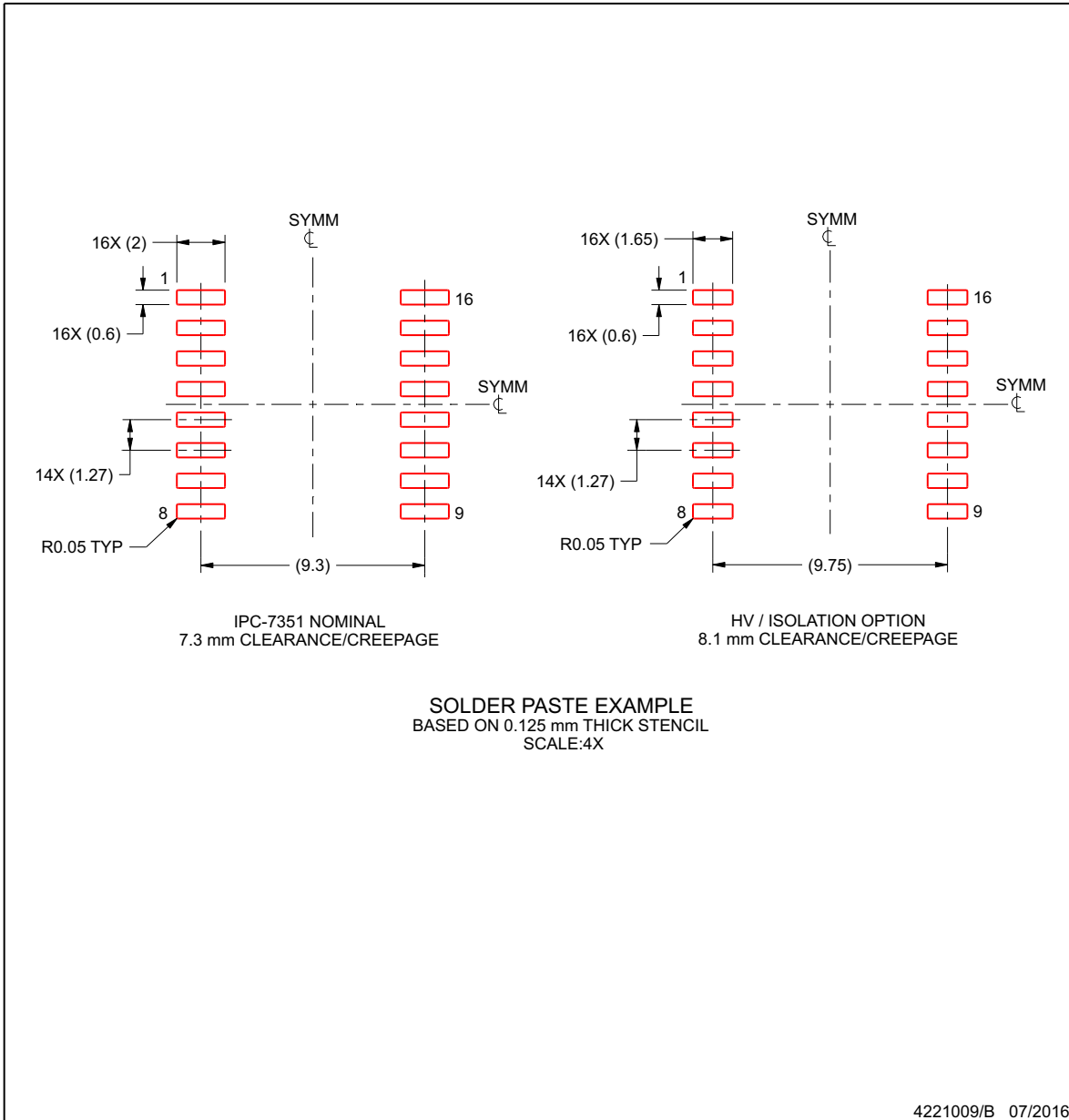
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

**EXAMPLE STENCIL DESIGN**

**DW0016B**

**SOIC - 2.65 mm max height**

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
ISO7740DBQ	PREVIEW	SSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-55 to 125	7740	
ISO7740DBQR	PREVIEW	SSOP	DBQ	16	2500	TBD	Call TI	Call TI	-55 to 125	7740	
ISO7740DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7740	<a href="#">Samples</a>
ISO7740DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7740	<a href="#">Samples</a>
ISO7740FDBQ	PREVIEW	SSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-55 to 125	7740F	
ISO7740FDBQR	PREVIEW	SSOP	DBQ	16	2500	TBD	Call TI	Call TI	-55 to 125	7740F	
ISO7740FDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7740F	<a href="#">Samples</a>
ISO7740FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7740F	<a href="#">Samples</a>
ISO7741DBQ	PREVIEW	SSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-55 to 125	7741	
ISO7741DBQR	PREVIEW	SSOP	DBQ	16	2500	TBD	Call TI	Call TI	-55 to 125	7741	
ISO7741DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7741	<a href="#">Samples</a>
ISO7741DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7741	<a href="#">Samples</a>
ISO7741FDBQ	PREVIEW	SSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-55 to 125	7741F	
ISO7741FDBQR	PREVIEW	SSOP	DBQ	16	2500	TBD	Call TI	Call TI	-55 to 125	7741F	
ISO7741FDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7741F	<a href="#">Samples</a>
ISO7741FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7741F	<a href="#">Samples</a>
ISO7742DBQ	PREVIEW	SSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-55 to 125	7742	
ISO7742DBQR	PREVIEW	SSOP	DBQ	16	2500	TBD	Call TI	Call TI	-55 to 125		
ISO7742DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7742	<a href="#">Samples</a>

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
ISO7742DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7742	<a href="#">Samples</a>
ISO7742FDBQ	PREVIEW	SSOP	DBQ	16	75	Green (RoHS & no Sb/Br)	Call TI	Level-2-260C-1 YEAR	-55 to 125	7742F	
ISO7742FDBQR	PREVIEW	SSOP	DBQ	16	2500	TBD	Call TI	Call TI	-55 to 125		
ISO7742FDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7742F	<a href="#">Samples</a>
ISO7742FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-55 to 125	ISO7742F	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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**OTHER QUALIFIED VERSIONS OF ISO7740, ISO7741, ISO7742 :**

- Automotive: [ISO7740-Q1](#), [ISO7741-Q1](#), [ISO7742-Q1](#)

**NOTE: Qualified Version Definitions:**

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects



**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7740DWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7740FDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7741DWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7741FDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7742DWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7742FDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7740DWR	SOIC	DW	16	2000	367.0	367.0	38.0
ISO7740FDWR	SOIC	DW	16	2000	367.0	367.0	38.0
ISO7741DWR	SOIC	DW	16	2000	367.0	367.0	38.0
ISO7741FDWR	SOIC	DW	16	2000	367.0	367.0	38.0
ISO7742DWR	SOIC	DW	16	2000	367.0	367.0	38.0
ISO7742FDWR	SOIC	DW	16	2000	367.0	367.0	38.0

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